TEXAS INSTRUMENTS

TMAG3001
SLYS053A – NOVEMBER 2023 – REVISED MARCH 2024

TMAG3001 Low-Power 3D Linear and Angle Hall-Effect Sensor With I^{2}C Interface and Wake Up Detection in WCSP

1 Features

- Configurable power modes including:
  - 2.1mA active mode current
  - 0.45µA wake-up and sleep mode current
  - 40nA sleep mode current
- Selectable linear magnetic range at X, Y, or Z axis:
  - TMAG3001A1 sample: ±40mT, ±80mT
  - TMAG3001A2: ±120mT, ±240mT
- Integrated angle calculation with gain and offset adjustment to support off-axis placement
- Conversion trigger by I^{2}C or dedicated $\overline{\text{INT}}$ pin
- Interrupt signal based on
  - Magnetic or Angle threshold crossing
  - Change from previous measurement
- Configurable 3D or angle switch mode
- Optimized for low noise, supporting up to 20kSPS single axis conversion rate
- I^{2}C interface with cyclic redundancy check (CRC):
  - Maximum 1MHz I^{2}C clock speed
  - ADDR pin enables four devices on the same bus
- Integrated temperature compensation to support multiple magnet types
- Built-in temperature sensor
- 1.65V to 3.6V supply voltage V$_{CC}$ range
- Operating temperature range: –40°C to 125°C

2 Applications

- Electronic smart locks
- Door and window sensors
- Magnetic proximity sensors
- Mobile robot motor control
- Smartwatches
- Actuators
- Position sensors
- Foldable smartphones and tablets
- Joystick and gaming controllers
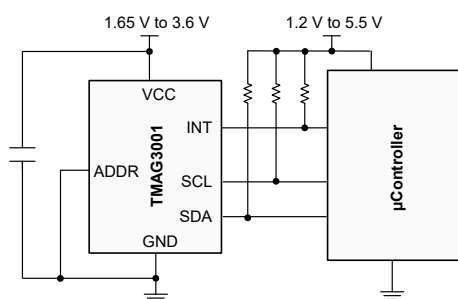
3 Description

The TMAG3001 is a low-power linear 3D Hall-effect sensor designed for a wide range of industrial and personal electronics applications. This device integrates three independent Hall-effect sensors in the X, Y, and Z axes. A precision analog signal-chain along with an integrated 12-bit ADC digitizes the measured analog magnetic field values. The I^{2}C interface, while supporting multiple operating V$_{CC}$ ranges, allows seamless data communication with low-voltage microcontrollers.

The TMAG3001 can be configured through the I^{2}C interface to enable any combination of magnetic axes and temperature measurements. Additionally, the device can be configured to various power options (including wake-up and sleep mode) allowing designers to optimize system power consumption based on their system-level needs. Multiple sensor conversion schemes and I^{2}C read frames help optimize throughput and accuracy. A dedicated $\overline{\text{INT}}$ pin can act as a system interrupt during low power wake-up and sleep mode, and can also be used by a microcontroller to trigger a new sensor conversion. The device also features a configurable low power switch mode for magnetic or angle measurements.

An integrated angle calculation engine (CORDIC) provides full 360° angular position information for both on-axis and off-axis angle measurement topologies. The angle calculation is performed using two user-selected magnetic axes. The device features magnetic gain and offset correction to mitigate the impact of system mechanical error sources.

The TMAG3001 features an ADDR pin that can be used to have four different I^{2}C addresses. Each orderable part can be configured to select one of two magnetic field ranges that suits the magnet strength and component placement during system calibration.

The device performs consistently across a wide ambient temperature range of –40°C to 125°C.

Package Information

PART NUMBER	PACKAGE[1]	PACKAGE SIZE[2]
TMAG3001	YBG (DSBGA, 6)	0.83mm × 1.32mm

(1) For all available packages, see the package option addendum at the end of the data sheet.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.

Application Block Diagram

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4 Pin Configuration and Functions
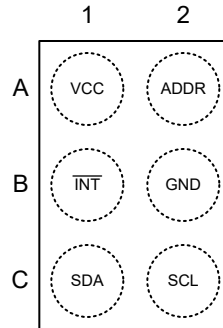
Figure 4-1. YBG (6 - DSBGA) Top View

Table 4-1. Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
VCC	A1	Power supply	Power supply.
INT	B1	IO	Interrupt output and Trigger Input. When used as an open-drain output a pull-up resistor is required. When used us a Trigger Input a pull-up is not required.
SDA	C1	IO	Serial data.
SCL	C2	IO	Serial clock.
GND	B2	Ground	Ground reference.
ADDR	A2	Input	Address pin. Can be connected to either SDA, SCL, VCC or GND.

5 Specifications

5.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)[1]

		MIN	MAX	UNIT
V_{CC}	Main supply voltage	−0.3	4	V
I_{OUT}	Output current, SDA, $\overline{INT}$	0	10	mA
V_{OUT}	Output voltage, SDA, $\overline{INT}$	−0.3	7	V
V_{IN}	Input voltage, SCL, SDA, ADDR, $\overline{INT}$	−0.3	7	V
B_{MAX}	Magnetic flux density		Unlimited	T
T_J	Junction temperature	−40	150	°C
T_{stg}	Storage temperature	−65	170	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

5.2 ESD Ratings

				VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001[1]		±2000	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002[2]	Corner pins (1, 6, 3, and 4)	±700	
			Other pins	±500	

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.

5.3 Thermal Information

THERMAL METRIC[1]		TMAG3001	UNIT
		YBG (WCSP)	
		6 pins	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	131.8	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	1.4	°C/W
$R_{\theta JC(bottom)}$	Junction-to-case (top) thermal resistance	N/A	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	36.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	0.3	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	36.4	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

5.4 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	1.65		3.6	V
V_{OUT}	Output voltage, SDA, $\overline{INT}$	0		3.6	V
I_{OUT}	Output current, SDA, $\overline{INT}$			2	mA
T_A	Operating free air temperature	−40		125	C

Product Folder Links: TMAG3001

5.5 Electrical Characteristics

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I/O Characteristics						
V_{OL}	Output LOW voltage, SDA, $\overline{INT}$ pin	I_{OUT} = 2mA	0		0.4	V
V_{IH}	Input HIGH voltage	V_{CC} = 1.65V - 1.9V	$0.7 \times V_{CC}$			V
		V_{CC} = 2.3V - 3.6V	$0.65 \times V_{CC}$			V
V_{IL}	Input LOW voltage	V_{CC} = 1.65V - 1.9V			$0.3 \times V_{CC}$	V
		V_{CC} = 2.3V - 3.6V			$0.35 \times V_{CC}$	V
I_{OZ}	Output leakage current, SDA, $\overline{INT}$ pin	Output disabled V_{OZ} = 5.5V			±100	nA
$t_{FALL\_\overline{INT}}$	$\overline{INT}$ output fall time	R_{PU} = 10kΩ C_L = 20pF		6		ns
$t_{INT (\overline{INT})}$	$\overline{INT}$ Interrupt time duration during pulse mode	INT_Mode[2:0] = 1h or 2h		10		µs
$t_{INT (SCL)}$	SCL Interrupt time duration	INT_Mode[2:0] = 3h or 4h		10		µs
C_{IN}	Input capacitance	f_s = 1MHz			10	pF
DC POWER SECTION						
I_{ACTIVE}	Active mode current X, Y, Z, or thermal sensor active conversion	LP_LN = 0h V_{CC} = 1.8V		2.1	3.5	mA
		LP_LN = 1h V_{CC} = 1.8V		2.8	4.5	mA
		LP_LN = 0h V_{CC} = 3.3V		2.4	4	mA
		LP_LN = 1h V_{CC} = 3.3V		3.0	4.8	mA
$I_{STANDBY}$	Stand-by mode current	Device in trigger mode, no conversion started		0.45	1	mA
I_{SLEEP}	Sleep mode current			40		nA
AVERAGE POWER DURING DUTY-CYCLE MODE						
I_{CC_DCM}	W&S mode current consumption Wake-up interval of 5000ms LP_LN = 0h	Magnetic 1-channel conversion V_{CC} = 1.8V		0.4	1.1	µA
		Magnetic 1-channel conversion V_{CC} = 3.3V		0.5	1.3	µA
	W&S mode current consumption Wake-up interval of 1ms Conv_AVG[2:0] = 0h LP_LN = 0h	Magnetic 1-channel conversion V_{CC} = 3.3V		110	250	µA
		Magnetic 4-channel conversion V_{CC} = 3.3V		230	375	µA

5.6 Temperature Sensor

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
T_{SENS_RANGE}	Temperature sensing range		–40		125	°C
T_{SENS_RES}	Temperature sensing resolution (in 16bit format)			58.2		LSB/°C
T_{ADC_T0}	Temperature result in decimal value at room temperature of 25ºC			17512		
T_{ERR}	Temperature error accuracy	T_A = –40°C to 125°C		± 0.5	± 5	°C
NRMS_T	RMS (1 Sigma) temperature noise	Conv_AVG = 5h		0.05		°C
NRMS_T	RMS (1 Sigma) temperature noise	Conv_AVG = 0h		0.3		°C

5.7 Magnetic Characteristics For A1

Advanced Information. Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$B_{IN\_X\_Y}$	Linear magnetic range	x_y_RANGE = 0h		±40		mT
$B_{IN\_X\_Y}$		x_y_RANGE = 1h		±80		mT
B_{IN_Z}		z_RANGE = 0h		±40		mT
B_{IN_Z}		z_RANGE = 1h		±80		mT
SENS	Sensitivity, X, Y, or Z axis LP_LN = 1h	±40mT range		840		LSB/mT
		±80mT range		420		LSB/mT
$SENS_{ERR}$	Sensitivity error, X, Y, Z axis LP_LN = 1h	T_A = 25°C		±0.5	±8	%
$SENS_{ERR\_DRIFT}$	Sensitivity drift from 25°C, X, Y, Z axis	T_A = -40°C to 85°C		±1.5	±8	%
		T_A = -40°C to 125°C			±10	%
$SENS_{LER\_XY}$	Sensitivity Linearity Error, X, Y-axis	T_A = 25°C		±0.10		%
$SENS_{LER\_Z}$	Sensitivity Linearity Error, Z axis			±0.10		%
$SENS_{MS\_XY}$	Sensitivity mismatch among X-Y axes	T_A = 25°C LP_LN = 1h		±0.75	±4	%
$SENS_{MS\_Z}$	Sensitivity mismatch among Y-Z, or X-Z axes			±0.55	±6	%
$SENS_{MS\_DR\_XY}$	Sensitivity mismatch drift from 25°C value; X-Y axes	T_A = -40°C to 125°C		±1.5	±4	%
$SENS_{MS\_DR\_Z}$	Sensitivity mismatch drift from 25°C value; Y-Z, or X-Z axes	T_A = -40°C to 125°C		±1.5	±6	%
B_{off}	Offset	T_A = 25°C		±100	± 500	µT
B_{off_TC}	Offset drift from 25°C value	T_A = -40°C to 125°C		±1	± 7	µT/°C
N_{RMS_XY}	RMS (1 Sigma) magnetic noise (X or Y-axis)	LP_LN = 0h Conv_AVG = 0h		105		µT
		LP_LN = 1h Conv_AVG = 0h		95		µT
		LP_LN = 0h Conv_AVG = 5h		17.5		µT
		LP_LN = 1h Conv_AVG = 5h		16		µT

Product Folder Links: *TMAG3001*

Advanced Information. Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
N_{RMS_Z}	RMS (1 Sigma) magnetic noise (Z axis)	LP_LN = 0h Conv_AVG = 0h		58		μT
		LP_LN = 1h Conv_AVG = 0h		53		μT
		LP_LN = 0h Conv_AVG = 5h		10		μT
		LP_LN = 1h Conv_AVG = 5h		9		μT
A_{ERR} [1]	X-Z Angle error in full 360° rotation (After gain and offset calibration)	T_A = 25°C Conv_AVG = 5h		± 0.5		deg
	X-Y Angle error in full 360° rotation (After gain and offset calibration)	T_A = 25°C Conv_AVG = 5h		± 0.25		deg
A_{NRMS} [1]	RMS (1 Sigma) angle noise (X-Y)	LP_LN = 1h Conv_AVG = 5h		0.03		deg
	RMS (1 Sigma) angle noise (X-Z or Y-Z)			0.025		deg

(1)   Angle measurements are performed with the magnet aligned to the sensor

5.8 Magnetic Characteristics For A2

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
B_{IN}	Linear magnetic range	_RANGE = 0h		±120		mT
		_RANGE = 1h		±240		mT
SENS	Sensitivity, X, Y, or Z axis LP_LN = 1h	±120mT range		273		LSB/mT
		±240mT range		137		LSB/mT
$SENS_{ERR}$	Sensitivity error, X, Y, Z axis LP_LN = 1h	T_A = 25°C		±0.5	±6	%
$SENS_{ERR\_DRIFT}$	Sensitivity drift from 25°C, X, Y, Z axis	T_A = 0°C to 125°C		±1.5	±6	%
$SENS_{LER}$	Sensitivity Linearity Error, X, Y-axis	T_A = 25°C		±0.10		%
	Sensitivity Linearity Error, Z axis	T_A = 25°C		±0.10		%
$SENS_{MS}$	Sensitivity mismatch among X-Y axes	T_A = 25°C LP_LN = 1h		±0.75	±4.5	%
	Sensitivity mismatch among Y-Z, or X-Z axes			±0.55	±6.5	%
$SENS_{MS\_DR}$	Sensitivity mismatch drift from 25°C value; X-Y axes	T_A = -40°C to 125°C		±1.5	±4	%
	Sensitivity mismatch drift from 25°C value; Y-Z, or X-Z axes	T_A = -40°C to 125°C		±1.5	±5.5	%
B_{off}	Offset	T_A = 25°C Range = 0h		±75	± 600	μT
		T_A = 25°C Range = 1h		±75	± 750	μT
B_{off_DR}	Offset drift from 25°C value	T_A = -40°C to 25°C		±1	±9.1	μT/°C
		T_A = 25°C to 125°C		±1	±8	μT/°C
N_{RMS_XY}	RMS (1 Sigma) magnetic noise (X or Y-axis)	LP_LN = 0h Conv_AVG = 0h		116		μT
		LP_LN = 1h Conv_AVG = 0h		106		μT
		LP_LN = 0h Conv_AVG = 5h		20		μT
		LP_LN = 1h Conv_AVG = 5h		19		μT
N_{RMS_Z}	RMS (1 Sigma) magnetic noise (Z axis)	LP_LN = 0h Conv_AVG = 0h		80		μT
		LP_LN = 1h Conv_AVG = 0h		77		μT
		LP_LN = 0h Conv_AVG = 5h		14.5		μT
		LP_LN = 1h Conv_AVG = 5h		14		μT
A_{ERR} [1]	Angle error T_A = 25°C Conv_AVG = 5h	X-Z Axes		±0.35	±0.85	deg
		X-Y Axes		±0.43	±1.4	deg
		Y-Z Axes		±0.17	±0.55	deg
	Angle error T_A = -40°C to 125°C Conv_AVG = 5h	X-Z Axes			±1.4	deg
		X-Y Axes			±2.25	deg
		Y-Z Axes			±2.0	deg

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
A_{NRMS} [1]	RMS (1 Sigma) angle noise (X-Y)	LP_LN = 1h Conv_AVG = 5h		0.03		deg
	RMS (1 Sigma) angle noise (X-Z or Y-Z)			0.025		deg

(1) Angle measurements are performed with the magnet aligned to the sensor with gain and offset calibration using X Y Z register output values.

5.9 Magnetic Temp Compensation Characteristics

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TC	Temperature compensation (X, Y, Z-axes)	TEMPCO = 0h		0		%/°C
		TEMPCO = 1h		0.12		%/°C
		TEMPCO = 2h		0.03		%/°C
		TEMPCO = 3h		0.2		%/°C

5.10 I²C Interface Timing

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

		FAST MODE		FAST MODE PLUS		UNIT
		MIN	MAX	MIN	MAX	
$f_{(SCL)}$	SCL operating frequency	1	400	1	1000	kHz
$t_{(BUF)}$	Bus-free time between STOP and START conditions	1.3		0.5		µs
$t_{(SUSTA)}$	Repeated START condition setup time	0.6		0.26		µs
$t_{(HDSTA)}$	Hold time after repeated START condition. After this period, the first clock is generated.	0		0		µs
$t_{(SUSTO)}$	STOP condition setup time	0.6		0.26		µs
$t_{(HDDAT)}$	Data hold time[1]	0	900	0	150	ns
$t_{(SUDAT)}$	Data setup time	100		50		ns
$t_{(LOW)}$	SCL clock low period	1.3		0.5		µs
$t_{(HIGH)}$	SCL clock high period	0.6		0.26		µs
t_R	SDA, SCL fall time	20	300		120	ns
t_F	SDA, SCL fall time	20 x (V_{CC} / 5.5V)	300	20 x (V_{CC} / 5.5V)	120	ns
t_{LPF}	Glitch suppression filter	50		50		ns

(1) The maximum $t_{(HDDAT)}$ can be 0.9µs for fast mode, and is less than the maximum $t_{(VDAT)}$ by a transition time.

5.11 Power up Timing

Over free–air temperature range and V_{CC} = 1.65V to 3.6V (unless otherwise noted); Typical specification are at T_A = 25°C and V_{CC} = 3.3V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{start\_power\_up}$	Time to go to stand-by mode after V_{CC} supply voltage crossing V_{CC_MIN}			270		µs
t_{start_sleep}	Time to go to stand-by mode from sleep mode[1]			50		µs
$t_{start\_measure}$	Time to go into continuous measure mode from stand-by mode			70		µs
$t_{measure}$	Conversion time	Conv_AVG[2:0] = 0h Operating_Mode[1:0] = 2h Only one channel enabled		50		µs
$t_{measure}$	Conversion time	Conv_AVG[2:0] = 5h Operating_Mode[1:0] = 2h Only one channel enabled		825		µs
t_{go_sleep}	Time to go into sleep mode after SCL goes high			20		µs

(1) The device will recognize the I2C communication from a controller only during stand-by or continuous measure modes. While the device is in sleep mode, a valid target address will wake up the device but no acknowledge will be sent to the controller. Start up time need to be considered before addressing the device after wake up.
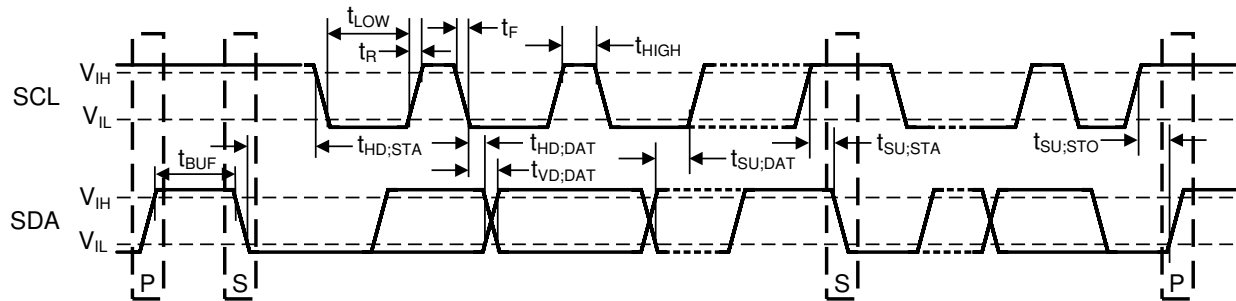
5.12 Timing Diagram

Figure 5-1. I²C Timing Diagram

Product Folder Links: *TMAG3001*

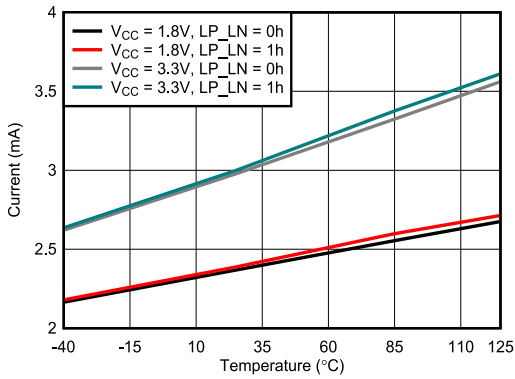## 5.13 Typical Characteristics

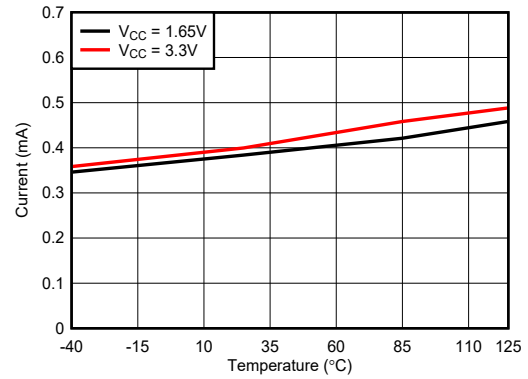**Figure 5-2. I$_{ACTIVE}$ vs Temperature**

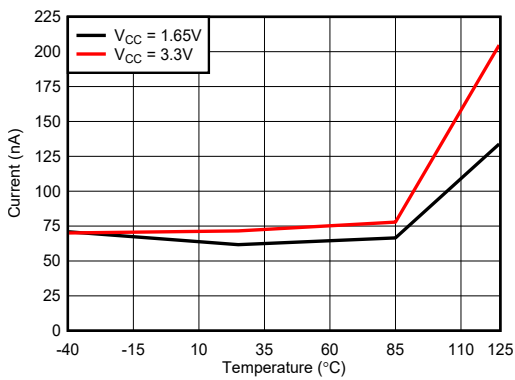**Figure 5-3. I$_{STANDBY}$ vs Temperature**
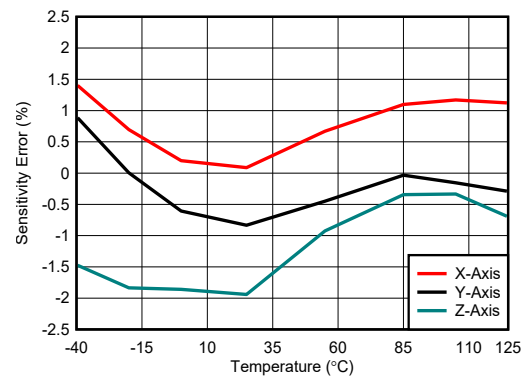

Figure 5-4. I$_{SLEEP}$ vs Temperature

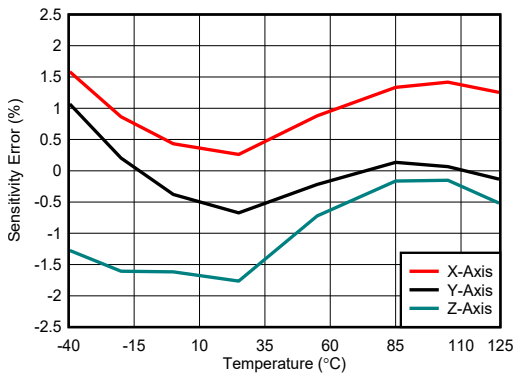**Figure 5-5. A2 Sensitivity Error vs Temperature, V$_{CC}$ = 1.8V**

Figure 5-6. A2 Sensitivity Error vs Temperature, V$_{CC}$ = 3.3V
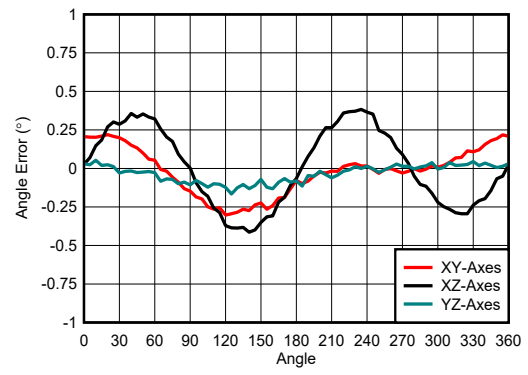

Figure 5-7. A2 Angle Error vs Angle, V$_{CC}$ = 3.3V, T$_A$ = 25°C

6 Detailed Description

6.1 Overview

The TMAG3001 IC is based on the Hall-effect technology and precision mixed signal circuitry from Texas Instruments. The output signals (raw X, Y, Z magnetic data and temperature data) are accessible through the I^2C interface.

The IC consists of the following functional and building blocks:

• The Power Management and Oscillator block contains a low-power oscillator, biasing circuitry and a fast oscillator.

• The sensing and temperature measurement block contains the Hall biasing, Hall sensors with multiplexers, noise filters, integrator circuit, temperature sensor, and the ADC. The Hall-effect sensor data and temperature data are multiplexed through the same ADC.

• The Interface block contains the I^2C control circuitry, ESD protection circuits, and all the I/O circuits. The TMAG3001 supports multiple I^2C read frames along with integrated cyclic redundancy check (CRC).

6.2 Functional Block Diagram

Product Folder Links: *TMAG3001*
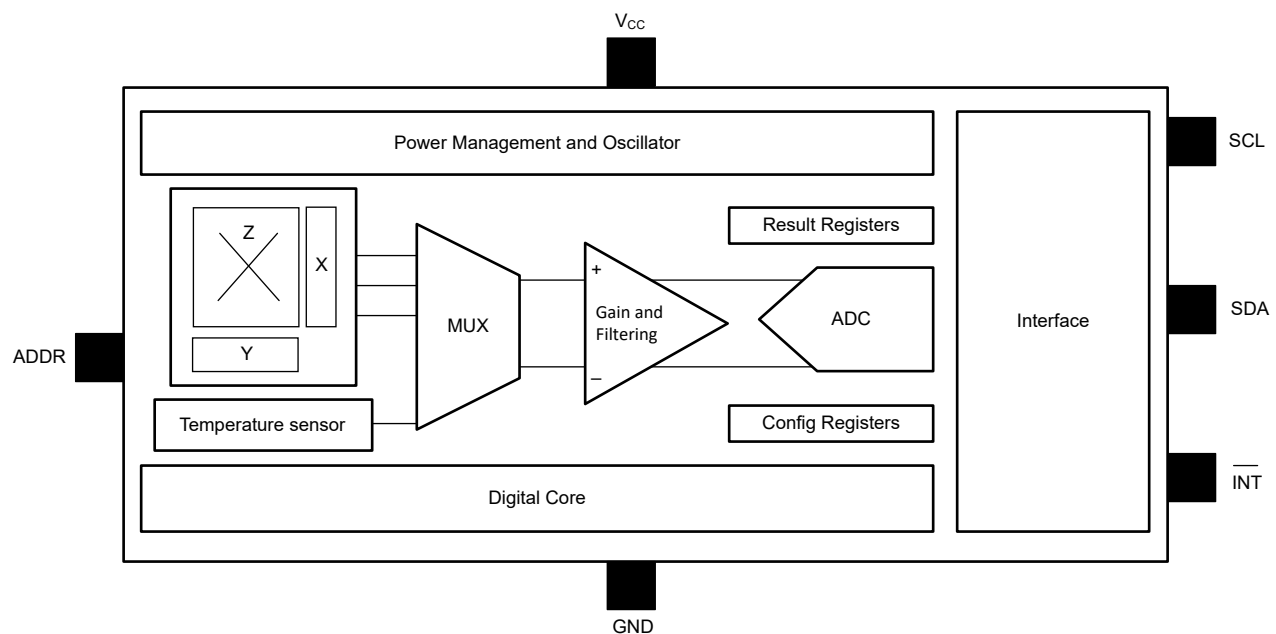
6.3 Feature Description

6.3.1 Magnetic Flux Direction

As shown in Figure 6-1, the TMAG3001 generates positive ADC codes in response to a magnetic north pole in the proximity for Y and Z axes, and a south pole in proximity for the X axis. Similarly, the TMAG3001 generates negative ADC codes if opposite magnetic poles approach from the same direction.
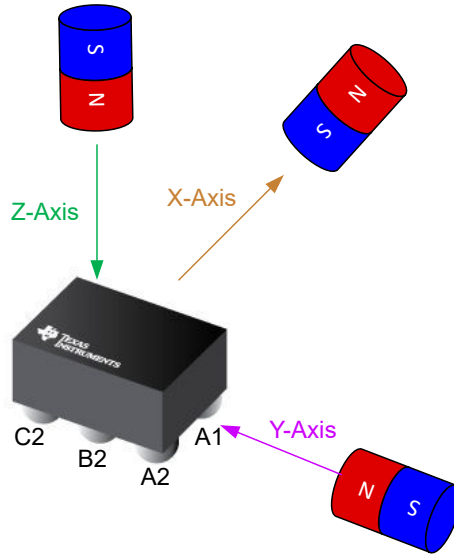

Figure 6-1. Direction of Sensitivity

6.3.2 Sensor Location

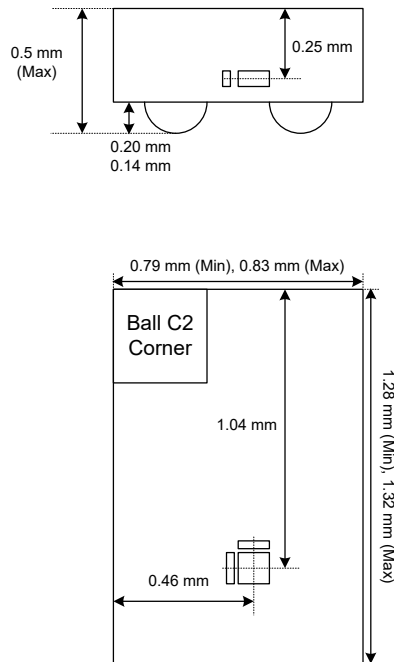Figure 6-2 shows the location of X, Y, Z Hall elements inside the TMAG3001.

Figure 6-2. Location of X, Y, Z Hall Elements

6.3.3 Interrupt Function

The TMAG3001 supports flexible and configurable interrupt functions through either the $\overline{INT}$ or the SCL pin. The $\overline{INT}$ pin operates as an open drain output. The INTB_POL bit selects the output level during an interrupt even when the $\overline{INT}$ pin is used for interrupt output. Table 6-1 shows the different interrupt modes supported by the device.

Table 6-1. Interrupt Modes

INT_MODE	MODE DESCRIPTION	OUTPUT PIN
0h	No interrupt	None
1h	Interrupt through $\overline{INT}$	$\overline{INT}$
2h	Interrupt through $\overline{INT}$	$\overline{INT}$
3h	Interrupt through SCL	SCL
4h	Interrupt through SCL except when I^{2}C busy	SCL
5h	Unipolar Switch Mode through $\overline{INT}$	$\overline{INT}$
6h	Omnipolar Switch Mode through $\overline{INT}$	$\overline{INT}$

Table 6-1 shows different conversion completion events where result registers and SET_COUNT bits update, and where they do not. The result registers that are used to create the interrupt events are updated only after the I^{2}C bus is not busy.

Table 6-2. Result Register and SET_COUNT Update After Conversion Completion

OUTPUT PIN	INT_MODE	I^{2}C BUS BUSY, NOT TALKING TO DEVICE		I^{2}C BUS BUSY and TALKING TO DEVICE		I^{2}C BUS NOT BUSY	
		RESULT UPDATE?	SET_COUNT UPDATE?	RESULT UPDATE?	SET_COUNT UPDATE?	RESULT UPDATE?	SET_COUNT UPDATE?
$\overline{INT}$		Yes	Yes	No	No	Yes	Yes
SCL	Interrupt through SCL	Yes	Yes	No	No	Yes	Yes
SCL	Interrupt through SCL except when I^{2}C busy	No	No	No	No	Yes	Yes

Note

TI does not recommend sharing the same I^{2}C bus with multiple target devices when using the SCL pin for interrupt function. The SCL interrupt can corrupt transactions with other target devices if present in the same I^{2}C bus.

Product Folder Links: *TMAG3001*

Interrupt Through SCL

Figure 6-3 shows an example for interrupt function through the SCL pin with the device programmed to wake up and sleep mode for threshold cross at a predefined intervals. The wake-up intervals can be set through the SLEEPTIME bits. After the magnetic threshold cross is detected, the device asserts a fixed width interrupt signal through the SCL pin, and remains in a low power wait state for a set period of time before the controller can address the interrupt event. The figure below shows a case where the controller responds to the interrupt event during the wait state and places the part back in the wake up and sleep mode.
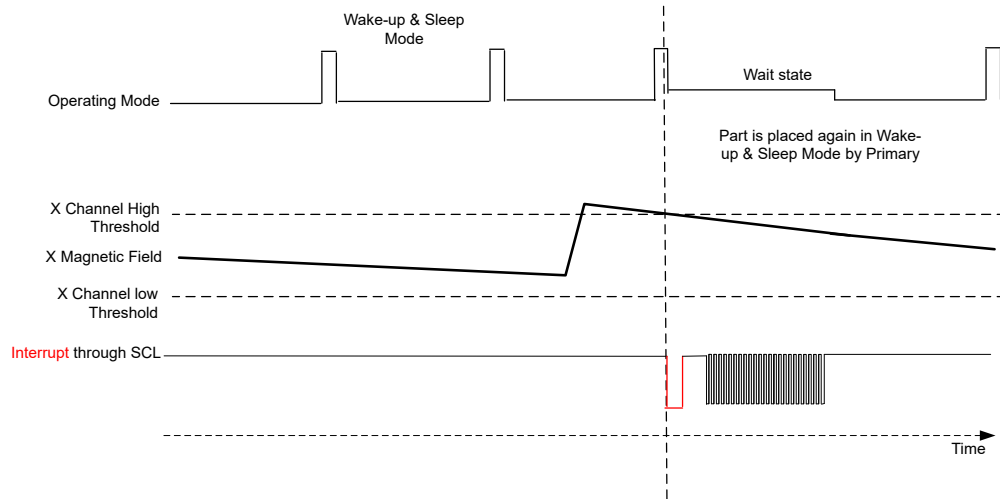
Figure 6-3. Interrupt Through SCL

Fixed Width Interrupt Through INT

Figure 6-4 shows an example for fixed-width interrupt function through the INT pin. The INT_STATE register bit is set 1b. After the magnetic threshold cross is detected, the device asserts a fixed width interrupt signal through the INT pin. If the device is programmed to be in wake-up and sleep mode to detect a magnetic threshold, then the device remains in a low power wait state for a set period of time before the controller can address the interrupt event. The latest results are saved and are accessible through the I^{2}C bus in the wait state. If the controller does not read the result registers in the wait time, the device enters to a low power state and continues to remain in the wake and sleep mode.
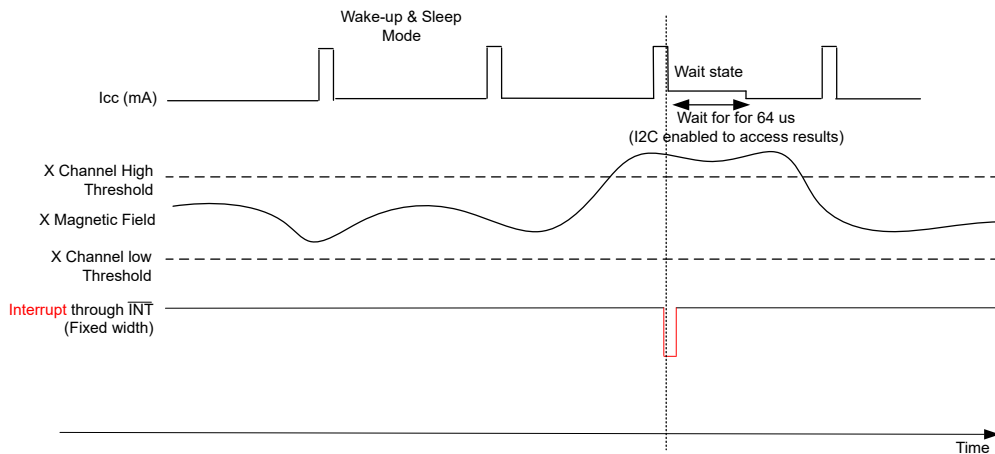
Figure 6-4. Fixed Width Interrupt Through INT

Latched Interrupt Through $\overline{\text{INT}}$

Figure 6-5 shows an example for latched interrupt function through the $\overline{\text{INT}}$ pin. The INT_STATE register bit is set 0b. After the magnetic threshold cross is detected, the device asserts a latched interrupt signal through the $\overline{\text{INT}}$ pin, and goes back to config mode. The interrupt latch is cleared only after the device receives a valid address through the SCL line. If the device is programmed to be in wake-up and sleep mode to detect a magnetic threshold, then the device remains in a low power wait state for a set period of time before the controller can address the interrupt event. If the controller enters the wait state, the device remains in the wait state where the I^{2}C is kept active.
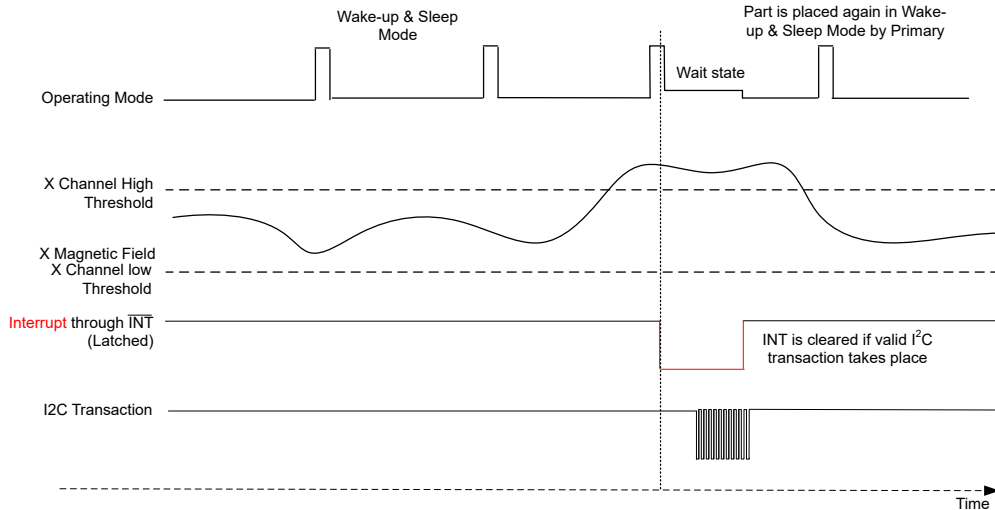

Figure 6-5. Latched Interrupt Through $\overline{\text{INT}}$

Unipolar Switch Through $\overline{\text{INT}}$

The TMAG3001 supports switch mode through the $\overline{\text{INT}}$ pin, where the device acts as a smart switch that can be configured to be sensitive for magnetic or angle threshold crossing. The device can be placed in this unipolar switch mode in standby, active or wake up and sleep modes. If the device is configured as a switch and placed in a low power wake up and sleep mode, the device remains in a low power wake up and sleep mode in case if any interrupt event is detected. Figure 6-6 shows an example for switch mode interrupt function through the $\overline{\text{INT}}$ pin. After the magnetic threshold cross is detected, the $\overline{\text{INT}}$ pin changes state.

Figure 6-6. Unipolar Switch Through $\overline{\text{INT}}$

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Omnipolar Switch Through $\overline{\text{INT}}$

The TMAG3001 supports omnipolar switch mode through the $\overline{\text{INT}}$ pin, where the device acts as a smart switch that can be configured to be sensitive for magnetic threshold crossing. Figure 6-7 shows an example for an omnipolar switch mode interrupt function through the $\overline{\text{INT}}$ pin. After the magnetic threshold cross is detected, the $\overline{\text{INT}}$ pin changes state. If the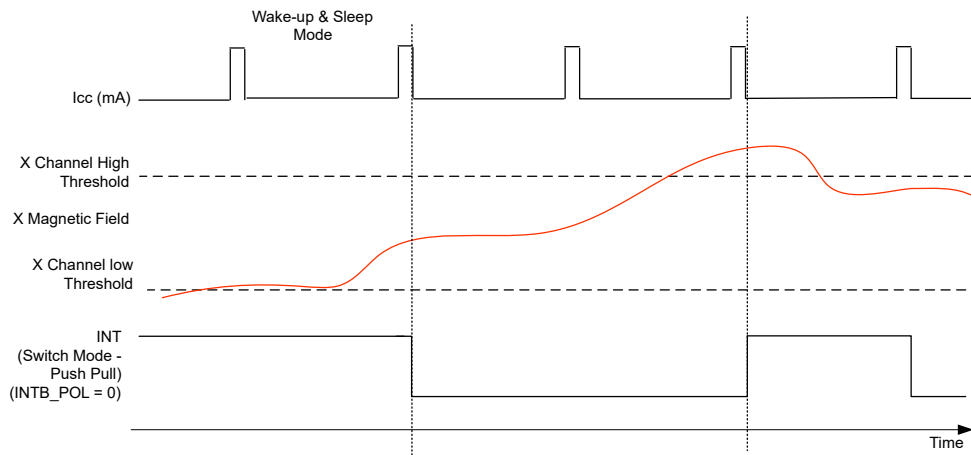 device is configured as an omnipolar switch, the device remains in a low power wake up and sleep mode in case if any interrupt event is detected.
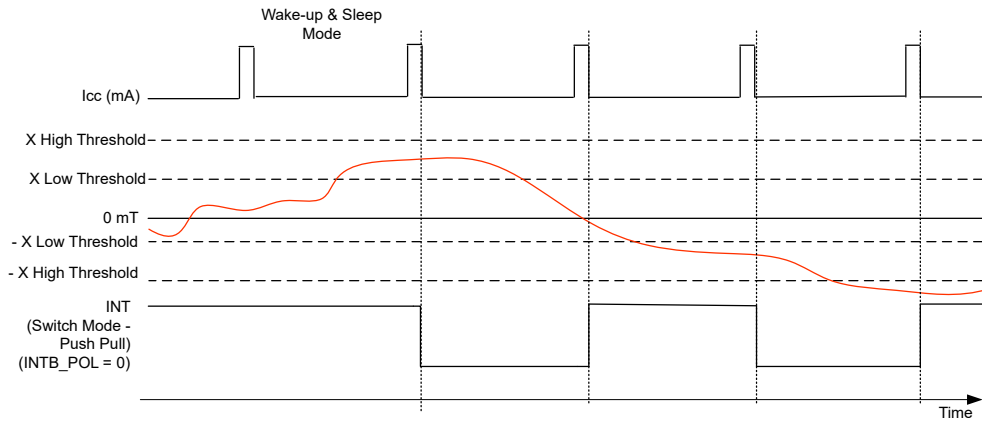

Figure 6-7. Omnipolar Switch Through $\overline{\text{INT}}$

Product Folder Links: *TMAG3001*

6.3.4 Wake on Change

The TMAG3001 enables relative magnetic limit checks for either magnetic fields or the angle measurements. For applications where only relative measurements are of interest, the device can be configured to respond through the WOC_SEL bits. In this mode, the device monitors either one of the magnetic axes or the angle output for a change and wakes up the system by providing an interrupt response based on INT_Mode[2:0] bits. When an interrupt response is obtained, the new sensor measurement is used as the reference threshold for the successive measurements. The wake on change feature is disabled when INT_Mode[2:0] is set to Unipolar or Omnipolar switch mode. The device can be configured to provide a wake on change response in standby, active or the wake and sleep mode.

When WOC_SEL is set to 2h, the device monitors for a change in output measurements on one of the configured magnetic axes. In this mode, tFigure 6-8 shows the device response, In this example, MAG_CH_EN is set to 1h, where the device is responsive to the X magnetic field. The new values of the reference thresholds are set to the sensor output value when the threshold was crossed. The hysteresis is configured using the THR_HYST bits. If the new measurement changes more than the previous measurement by the set hysteresis value, then an interrupt response is provided. Here the INT_Mode[2:0] is to 1h to provide interrupt response through the INT pin and INT_State is set to 1h, to provide a fixed interrupt response.

The wake on change feature will treat an angle transition from 0° to 359°, or 359° to 0°, as a net change of 359° to compare against the threshold settings.
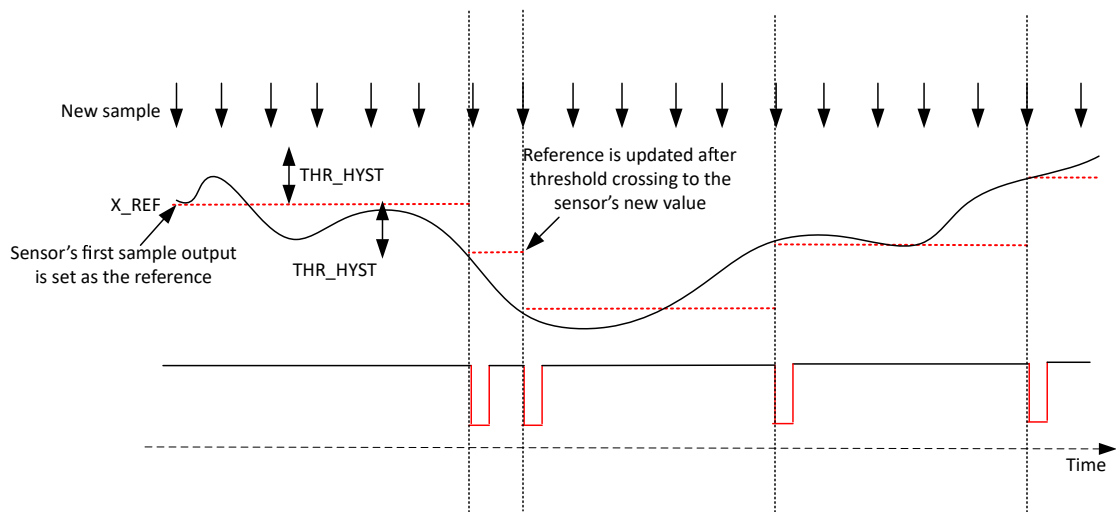

Figure 6-8. Wake on Change With Magnetic Axes Measurements , WOC_SEL = 2h, INT_State = 1h

Figure 6-9 shows the device response, when WOC_SEL = 1h, where the device is responsive to the angle measurements as set using the ANGLE_EN bits. The thresholds of the present measurement are set based on the previous measured value and the hysteresis as configured using the ANG_HYS bits. If the new measurement changes more than the previous measurement by the set hysteresis value, then an interrupt response is provided.
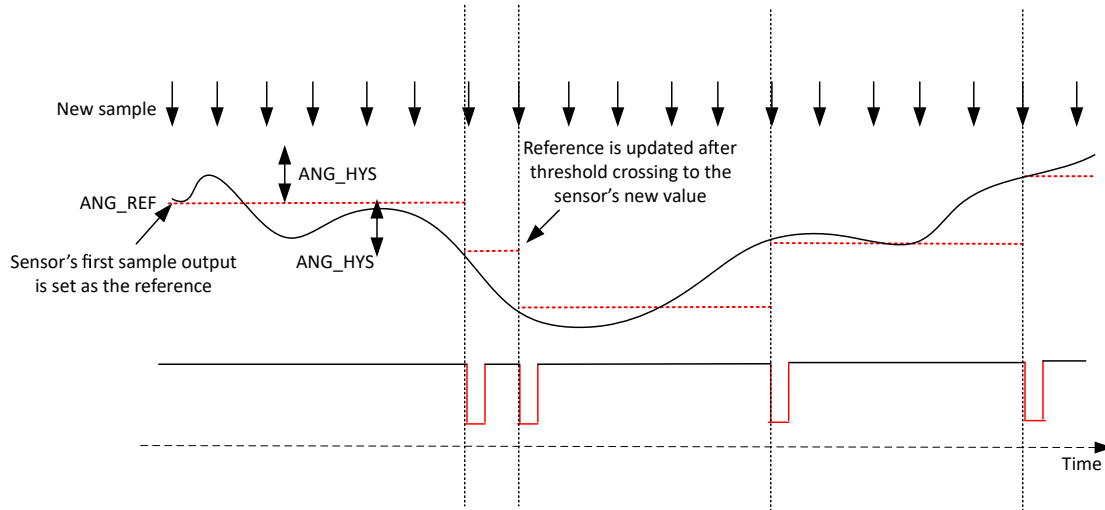

Figure 6-9. Wake on Change With Angle Measurements , WOC_SEL = 1h, INT_State = 1h

6.3.5 Device I^{2}C Address

Table 6-3 shows the default factory programmed I^{2}C addresses of the TMAG3001 and the four different address options that can be obtained using the ADDR pin for each of the device versions. The ADDR pin is only sampled in the Standby or Continuous mode, Operating_Mode[1:0] = 0h or 2h. If the I2C_Address_Update_EN is set to 1h, the TMAG3001 uses the I2C_Address[6:0] as the device address. If using Operating_Mode[1:0] = 1h or 3h, the I2C_Address[6:0] bit field must be updated with the desired I^{2}C address and I2C_Address_Update_En set to 1h. It is possible to assign up to 128 unique addresses by setting the I2C_Address_Update_EN bit to 1h.

Table 6-3. I^{2}C Default Address

DEVICE VERSION	MAGNETIC RANGE	ADDR pin connection	I^{2}C ADDRESS (7 MSB BITS)	I^{2}C WRITE ADDRESS (8-BIT)	I^{2}C READ ADDRESS (8-BIT)
TMAG3001Ax	±40mT, ±80mT, ±120mT, ±240mT	GND	34h	68h	69h
		VCC	35h	6Ah	6Bh
		SDA	36h	6Ch	6Dh
		SCL	37h	6Eh	6Fh

An example procedure to use the ADDR designated I^{2}C Address in any Operating_Mode[1:0] is shown here. Adjust the I2C_Address[6:0] as necessary for your system configuration.

- Power up TMAG3001 with ADDR connected to SDA
- Write 6Dh to register 0Ch (I2C_Address) to set the 7-bit I2C_Address[6:0] to 36h until the device is powered-down.
- Configure the Operating_Mode[1:0] as desired

6.3.6 Magnetic Range Selection

Table 6-4 shows the magnetic range selection for the TMAG3001 device. The X, Y, and Z axes range can be selected with the X_Y_RANGE and Z_RANGE register bits.

Table 6-4. Magnetic Range Selection

	RANGE REGISTER SETTING	TMAG3001A1[1]	TMAG3001A2	COMMENT
X, Y Axis Field	X_Y_RANGE = 0h	±40mT	±120mT	Higher resolution
	X_Y_RANGE = 1h	±80mT	±240mT	Higher range
Z Axis Field	Z_RANGE = 0h	±40mT	±120mT	Higher resolution
	Z_RANGE = 1h	±80mT	±240mT	Higher range

1. Advanced Information

6.3.7 Update Rate Settings

The TMAG3001 offers multiple update rates to offer design flexibility to system designers. The different update rates can be selected with the Conv_AVG[2:0] register bits. Table 6-5 shows different update rate settings for the TMAG3001.

Table 6-5. Update Rate Settings

OPERATING MODE	REGISTER SETTING	UPDATE RATE			COMMENT
		SINGLE AXIS	TWO AXES	THREE AXES	
X, Y, Z Axis	Conv_AVG[2:0] = 0h	20.0kSPS	13.3kSPS	10.0kSPS	Fastest update rate
X, Y, Z Axis	Conv_AVG[2:0] = 1h	13.3kSPS	8.0kSPS	5.7kSPS	
X, Y, Z Axis	Conv_AVG[2:0] = 2h	8.0kSPS	4.4kSPS	3.1kSPS	
X, Y, Z Axis	Conv_AVG[2:0] = 3h	4.4kSPS	2.4kSPS	1.6kSPS	
X, Y, Z Axis	Conv_AVG[2:0] = 4h	2.4kSPS	1.2kSPS	0.8kSPS	
X, Y, Z Axis	Conv_AVG[2:0] = 5h	1.2kSPS	0.6kSPS	0.4kSPS	Best SNR case

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6.4 Device Functional Modes

The TMAG3001 supports multiple functional modes for wide array of applications as explained in Figure 6-10. A specific functional mode is selected by setting the corresponding value in the Operating_Mode[1:0] register bits. The device starts powering up after VCC supply crosses the minimum threshold as specified in the *Recommended Operating Condition* (ROC) table. During any mode of operation, triggering a conversion during an on-going conversion is ignored. The on-going conversion does not restart.

6.4.1 Standby (Trigger) Mode

The TMAG3001 goes to standby mode after first time powering up. At this mode the digital circuitry and oscillators are on, and the device is ready to accept commands from the controller device. Based off the commands the device can start a sensor data conversion, go to power saving mode, or start data transfer through I^{2}C interface. A new conversion can be triggered through I^{2}C command or through $\overline{\text{INT}}$ pin. When using an I^{2}C trigger, the conversion starts immediately after the trigger bit is clocked with the SCL line. In this mode the device retains the immediate past conversion result data in the corresponding result registers. The time the device takes to go to standby mode from power up is denoted by $T_{start\_power\_up}$.

6.4.2 Sleep Mode

The TMAG3001 supports an ultra-low power sleep mode where the device retains the critical user configuration settings. In this mode the device does not retain the conversion result data. A controller can wake up the device from sleep mode through I^{2}C communications or the $\overline{\text{INT}}$ pin. The time the device takes to go to standby mode from sleep mode is denoted by T_{start_sleep}.

6.4.3 Wake-Up and Sleep (W&S) Mode

In this mode the TMAG3001 can be configured to go to sleep and wake up at a certain interval, and measure sensor data based off the SLEEP_TIME register bits setting. The device can be set to generate an interrupt through the INT_CONFIG_1 register. After the conversion is complete and the interrupt condition is met, the TMAG3001 exits the W&S mode and go to the wait state for a fixed period of time. In this state, the last measured data is stored in the corresponding result registers. If the controller does not respond to the interrupt event in the wait state, then the device continues to be in (W&S) mode. If the interrupt condition is not met, the device stays in the W&S mode to wake up and measure data at the specified interval. A controller can wake up the TMAG3001 anytime during the W&S mode through I^{2}C bus or $\overline{\text{INT}}$ pin. The time the device takes to go to standby mode from W&S mode is denoted by T_{start_sleep}.

Reading from the TMAG3001 after an interrupt puts the device in standby mode. The TMAG3001 must be configured back to Wake-up and Sleep mode if an I^{2}C read is executed after an interrupt.

6.4.4 Continuous Measure Mode

In this mode the TMAG3001 continuously measures the sensor data per Sensor_Config & Device_Config register settings. In this mode the result registers can be accessed through the I^{2}C lines. The time the device takes to go from standby mode to continuous measure mode is denoted by $T_{start\_measure}$.
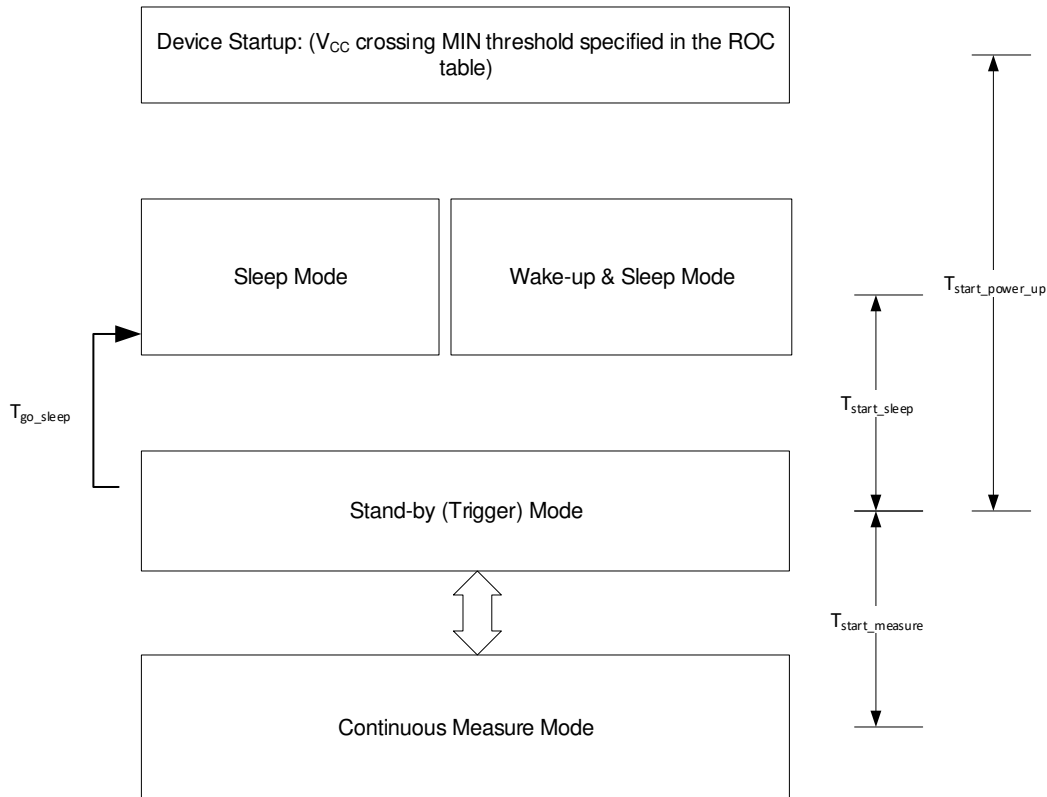
Figure 6-10. TMAG3001 Power-Up Sequence

Table 6-6 shows different device operational modes of the TMAG3001.

Table 6-6. Operating Modes

OPERATING MODE	DEVICE FUNCTION	ACCESS TO USER REGISTERS	RETAIN USER CONFIGURATION	COMMENT
Continuous Measure Mode	Continuously measuring x, y, z axis, or temperature data	Yes	Yes	
Standby Mode	Device is ready to accept I^{2}C commands and start active conversion	Yes	Yes	
Wake-up and Sleep Mode	Wakes up at a certain interval to measure the x, y, z axis, or temperature data	No	Yes	1, 5, 10, 15, 20, 30, 50, 100, 500, 1000, 2000, 5000, & 20000ms intervals supported.
Sleep Mode	Device retains key configuration settings, but does not retain the measurement data	No	Yes	Sleep mode can be utilized by a Controller device to implement other power saving intervals not supported by wake-up and sleep mode.

6.5 Programming

6.5.1 I²C Interface

The TMAG3001 has a standard bidirectional I²C interface that is controlled by a controller device to be configured or read the status of the device. Each target on the I²C bus has a specific device address to differentiate between other target devices that are on the same I²C bus. Many target devices require configuration upon start-up to set the behavior of the device. This is typically done when the controller accesses internal register maps of the target, which have unique register addresses. A device can have one or multiple registers where data is stored, written, or read. At the start bit of an I²C transaction, the conversion result registers are locked to the most recent completed conversion to prevent the results from changing mid transaction. If a conversion is completed mid I²C transaction, the device updates the results register with the new values immediately after the stop condition. The TMAG3001 supports transmission data rates up to 1MHz.

The physical I²C interface consists of the serial clock (SCL) and serial data (SDA) lines. Both SDA and SCL lines must be connected to a supply through a pullup resistor. The size of the pullup resistor is determined by the amount of capacitance on the I²C lines and the communication frequency. For further details, see the I²C Pullup Resistor Calculation application report. Data transfer can only be initiated when the bus is idle. A bus is considered idle if both SDA and SCL lines are high after a STOP condition.

The following is the general procedure for a controller to access a target device:

1. If a controller wants to send data to a target:
   - Controller-transmitter sends a START condition and addresses the target-receiver.
   - Controller-transmitter sends the requested register to write target-receiver.
   - Controller-transmitter sends data to target-receiver.
   - Controller-transmitter terminates the transfer with a STOP condition.
2. If a controller wants to receive or read data from a target:
   - Controller-receiver sends a START condition and addresses the target-transmitter.
   - Controller-receiver sends the requested register to read to target-transmitter.
   - Controller-receiver sends a RESTART condition and addresses the target-transmitter.
   - Controller-receiver receives data from the target-transmitter.
   - Controller-receiver terminates the transfer with a STOP condition.
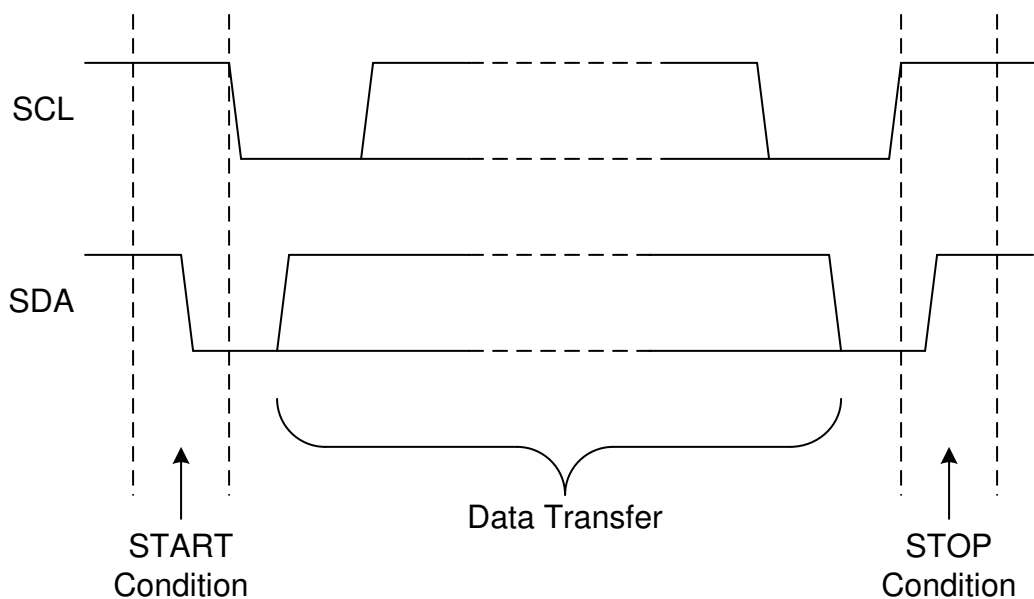
Figure 6-11. Definition of Start and Stop Conditions

SDA line is stable while SCL line is high

Byte: 1010 1010 (AAh)
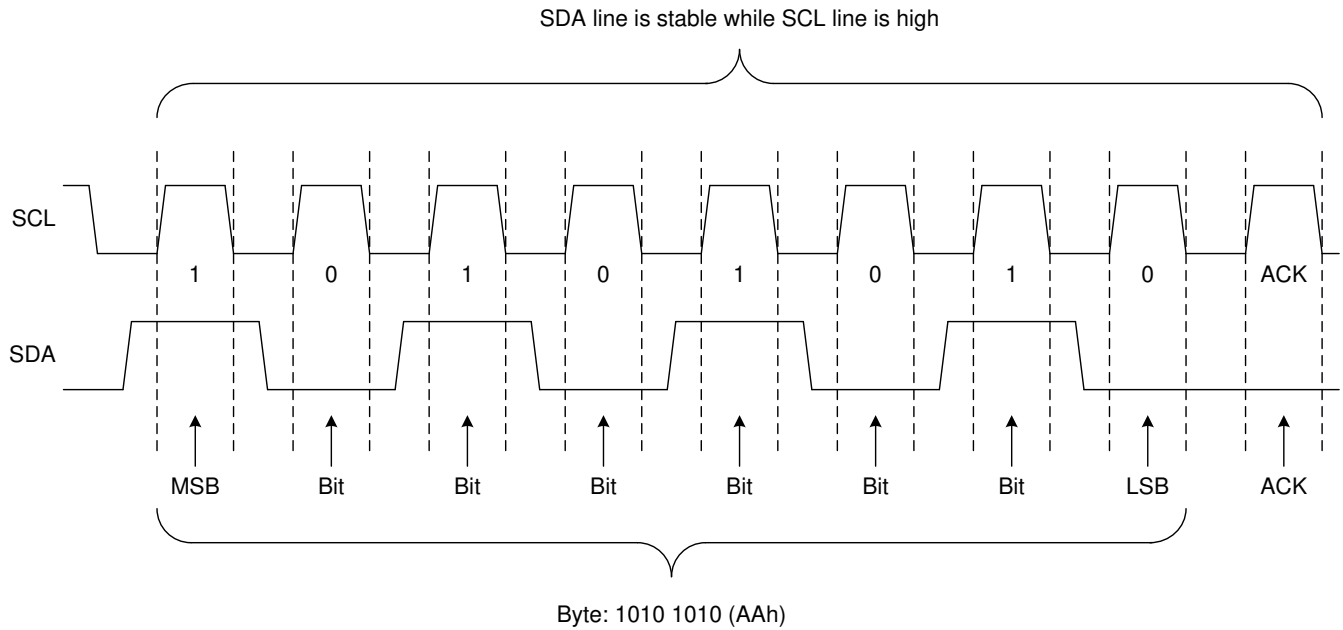
Figure 6-12. Bit Transfer

6.5.1.1 Conversion Trigger

The TMAG3001 supports the use of a Conversion Trigger bit to start a new conversion. Write a 1 to this bit to start a new conversion after the register address decoding is completed. The last 7 bits of the control register contain the Register Pointer Address.

Figure 6-13 shows the structure of the Control Register

Controller controls SDA line

Target controls SDA line

Register Pointer Address (N)

| T | P6 | P5 | P4 | P3 | P2 | P1 | P0 | A |

Conversion Trigger   ACK from Target

Figure 6-13. Control Register

Product Folder Links: *TMAG3001*

6.5.1.2 Bus Transactions

Data must be sent to and received from the target devices, and this is accomplished by reading from or writing to registers in the target device.

Registers are locations in the memory of the target which contain information, whether the information is configuration information or some sampled data to send back to the controller. The controller must write information to these registers to instruct the target device to perform a task.

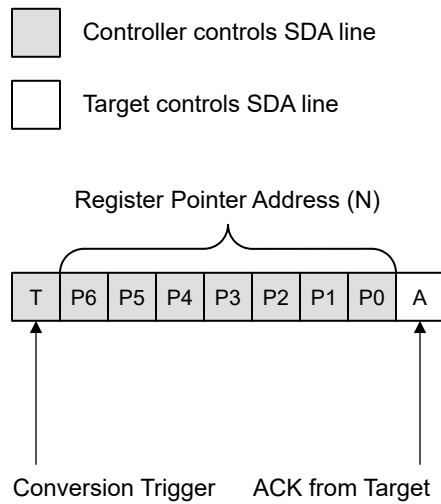The I2C_RD[1:0] and CRC_EN settings can modify how I^{2}C Read transactions are performed as shown in the following sections. When I2D_RD[1:0] is set to 0h or 3h, only Standard I^{2}C Reads can be used. If I2C_RD[1:0] is set to 1h or 2h, only the respective read command can be used.

The device returns 00h when reading registers outside of the register map. Setting changes during write transactions are acted upon after the last edge

6.5.1.2.1 Three Channels I^{2}C Write

To write on the I^{2}C bus, the controller sends a START condition on the bus with the address of the target, as well as the last bit (the R/W bit) set to 0b, which signifies a write. The target acknowledges, letting the controller know the target is ready. After this, the controller starts sending the control register data to the target until the controller has sent all the data necessary, and the controller terminates the transmission with a STOP condition. The device auto increments the register address pointer after each byte.
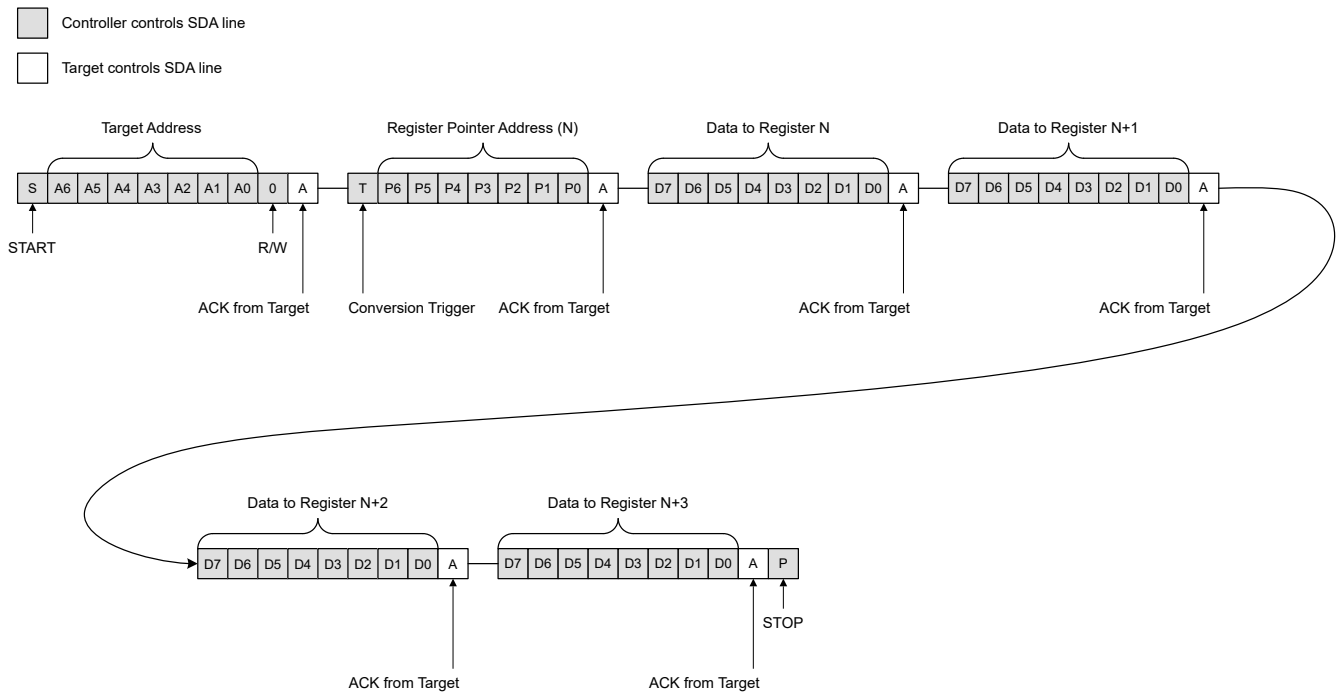

Figure 6-14. Standard I^{2}C Write

Product Folder Links: *TMAG3001*

6.5.1.2.2 General Call Write

The TMAG3001 supports the general call I^{2}C write command. This allows the configuration of multiple devices at the same time.
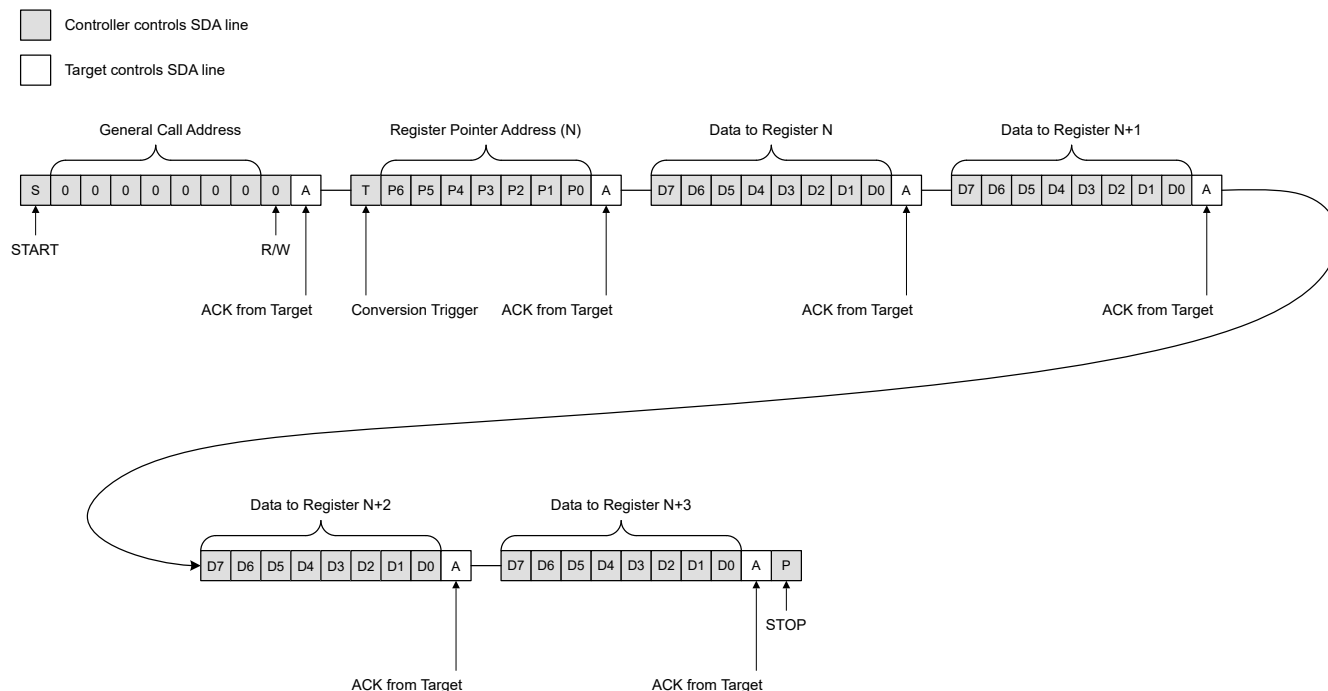
Figure 6-15. General Call I^{2}C Write

6.5.1.2.3 Standard I^{2}C Read

For a read operation the controller sends a START condition, followed by the target address with the R/W bit set to 0b (signifying a write). The target acknowledges the write request, and the controller sends the control byte with the Conversion Trigger bit and Register Pointer Address. After the Control Register, the controller will initiate a restart followed by the target address with the R/W bit set to 1b (signifying a read). The controller will continue to send out clock pulses but releases the SDA line so that the target can transmit data. At the end of every byte of data, the controller sends an ACK to the target, letting the target know that the controller is ready for more data. After the controller has received the number of bytes the controller expected, the controller sends a NACK, signaling to the target to halt communications and release the SDA line. The controller follows this up with a STOP condition.
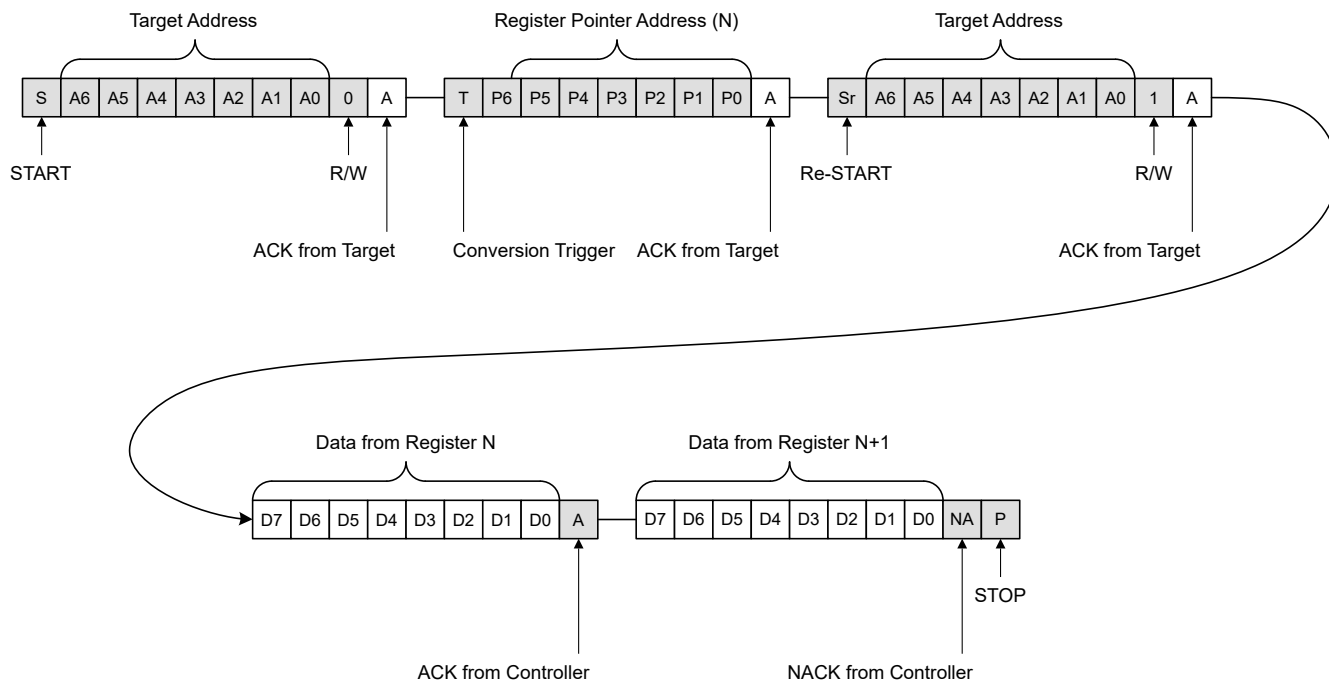
Figure 6-16. Standard I²C Read With CRC Disabled
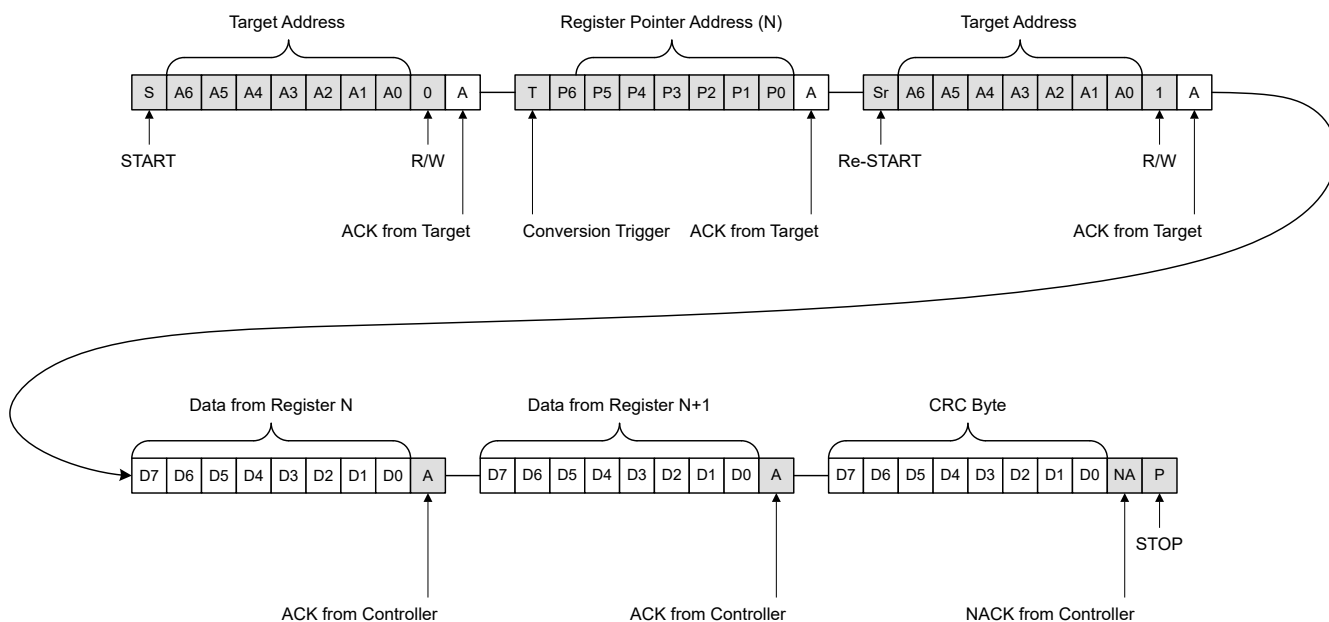
Figure 6-17. Standard I²C Read With CRC Enabled

6.5.1.2.4 I²C Read Command for 16-bit Data

The TMAG3001 allows the user to read from the result registers without writing to the control register and setting the address pointer when I2C_RD[1:0] = 1h for MSB and LSB data. When multiple channels are enabled, data is sent in the order of X-axis, Y-axis, Z-axis, and Conv_Status. When a channel is disabled, the channel is skipped in the data sequence.

In the Read Command for 16-bit data, only up to three channels of data can be sent when CRC is enabled. This restriction does not apply if CRC is disabled.
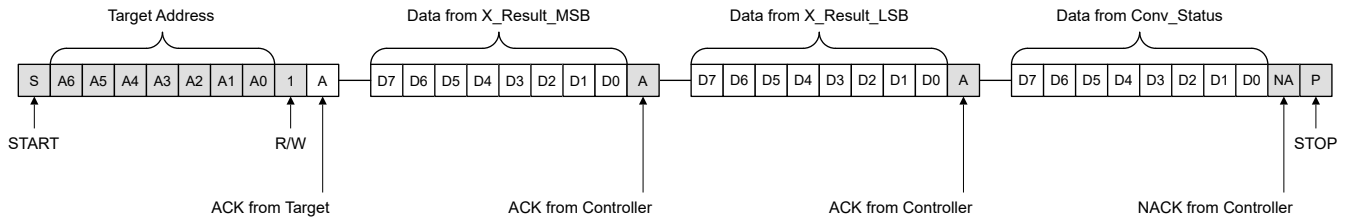
Figure 6-18. I²C Read Command for 16-bit Data With CRC Disabled, X-Axis Enabled

Figure 6-19. I²C Read Command for 16-Bit Data With CRC Disabled, Y and Z Axes Enabled

Product Folder Links: *TMAG3001*
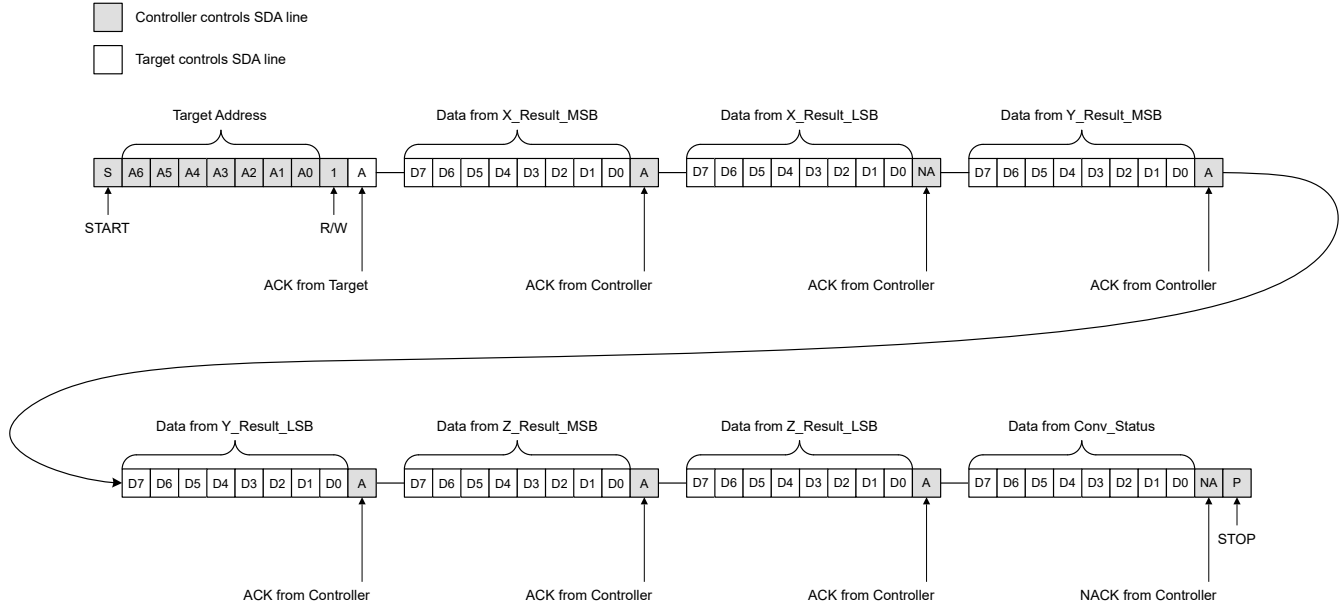
Figure 6-20. I²C Read Command for 16-Bit Data With CRC Disabled, X, Y, and Z Axes Enabled

Only the X-axis with CRC is shown, but other channels that are enabled use the same sequence format.
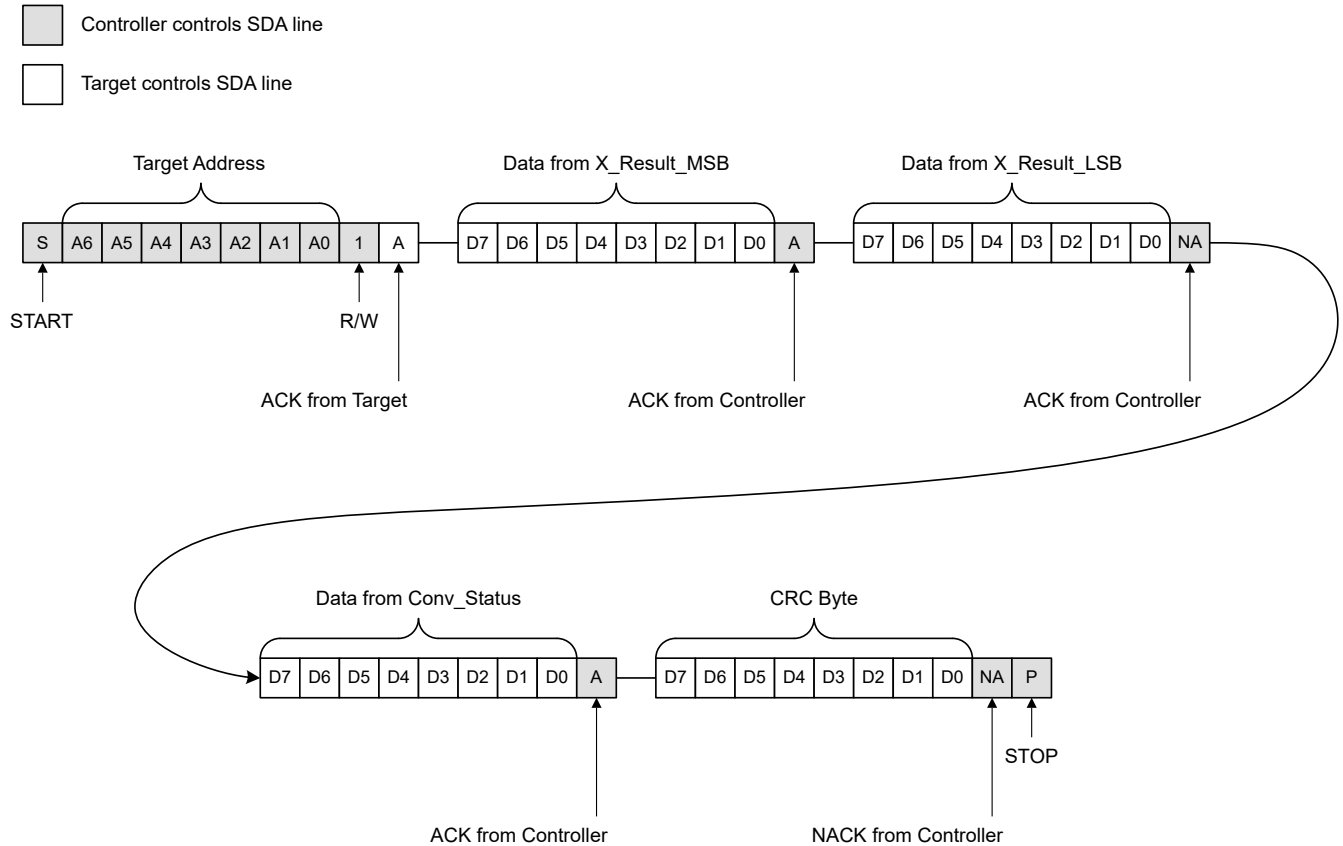
Figure 6-21. I²C Read Command for 16-Bit Data With CRC Enabled, X-Axis Enabled

6.5.1.2.5 I²C Read Command for 8-Bit Data

The TMAG3001 allows the user to read from the result registers without writing to the control register and setting the address pointer when I2C_RD[1:0] = 2h for MSB data only. When multiple channels are enabled, data is sent in the order of X-axis, Y-axis, Z-axis, and Conv_Status. When a channel is disabled, the channel is skipped in the data sequence.

In the Read Command for 8-bit data, only up to three channels of data can be sent when CRC is enabled. This restriction does not apply if CRC is disabled.
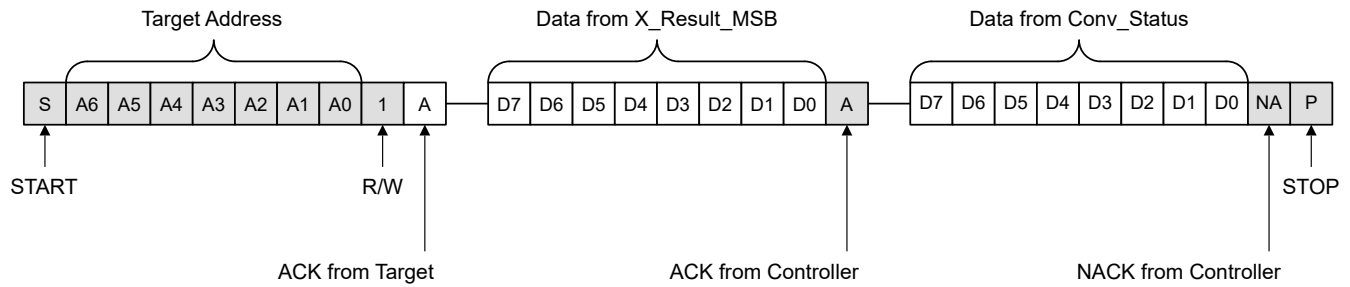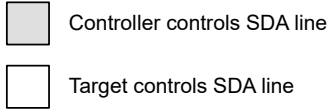
Figure 6-22. I²C Read Command for 8-Bit Data With CRC Disabled, X-Axis Enabled
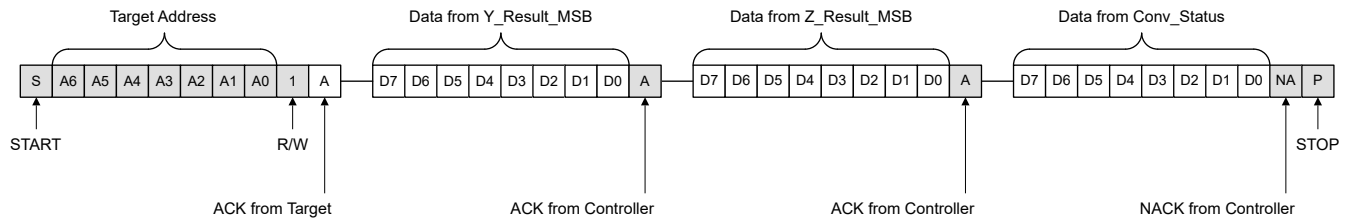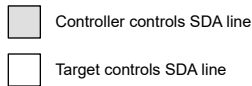
Figure 6-23. I²C Read Command for 8-Bit Data With CRC Disabled, Y and Z Axes Enabled

Controller controls SDA line

Target controls SDA line
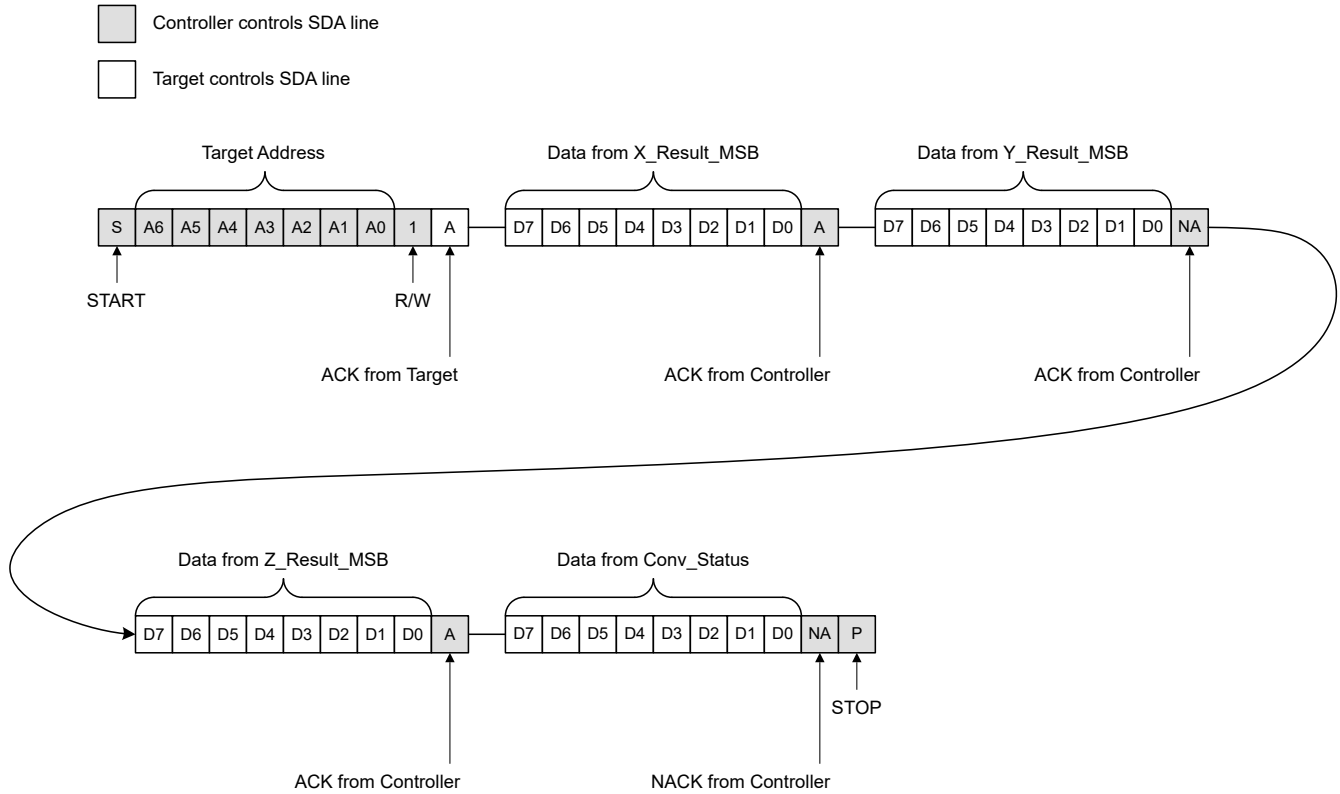
Figure 6-24. I²C Read Command for 8-Bit Data With CRC Disabled, X, Y, and Z Axes Enabled

Only the X-axis with CRC is shown, but other channels that are enabled use the same sequence format.

Controller controls SDA line

Target controls SDA line
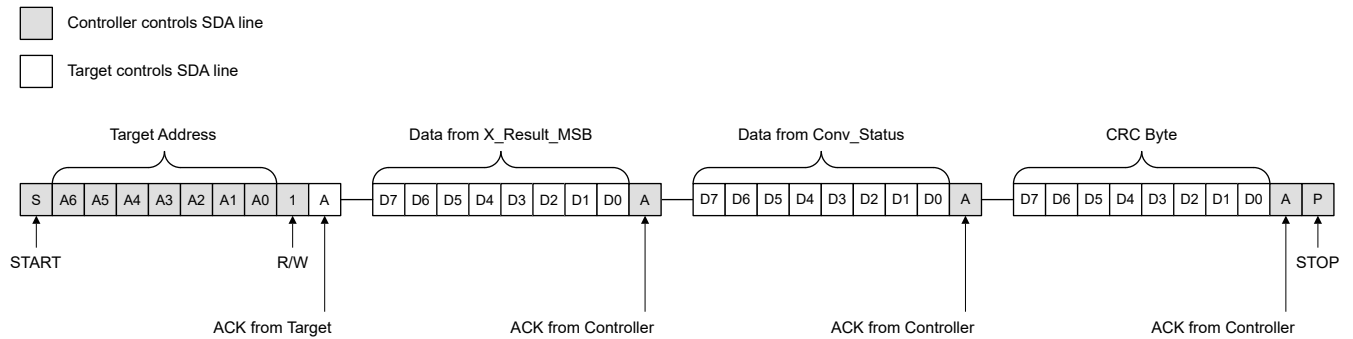
Figure 6-25. I²C Read Command for 8-Bit Data With CRC Enabled, X-Axis Enabled

6.5.1.2.6 I²C Read CRC

The TMAG3001 supports optional CRC during I²C read. The CRC can be enabled through the CRC_EN register bit. The CRC is performed on a data string that is determined by the I²C read type. The CRC information is sent as a single byte after the data bytes. The code is generated by the polynomial $x^8 + x^2 + x + 1$. Initial CRC bits are FFh.

The following equations can be employed to calculate CRC:

$$d = \text{Data Input}, \ c = \text{Initial CRC (FFh)} \tag{1}$$

$$\text{newcrc}[0] = d[7] \wedge d[6] \wedge d[0] \wedge c[0] \wedge c[6] \wedge c[7] \tag{2}$$

$$\text{newcrc}[1] = d[6] \wedge d[1] \wedge d[0] \wedge c[0] \wedge c[1] \wedge c[6] \tag{3}$$

$$\text{newcrc}[2] = d[6] \wedge d[2] \wedge d[1] \wedge d[0] \wedge c[0] \wedge c[1] \wedge c[2] \wedge c[6] \tag{4}$$

$$\text{newcrc}[3] = d[7] \wedge d[3] \wedge d[2] \wedge d[1] \wedge c[1] \wedge c[2] \wedge c[3] \wedge c[7] \tag{5}$$

$$\text{newcrc}[4] = d[4] \wedge d[3] \wedge d[2] \wedge c[2] \wedge c[3] \wedge c[4] \tag{6}$$

$$\text{newcrc}[5] = d[5] \wedge d[4] \wedge d[3] \wedge c[3] \wedge c[4] \wedge c[5] \tag{7}$$

$$\text{newcrc}[6] = d[6] \wedge d[5] \wedge d[4] \wedge c[4] \wedge c[5] \wedge c[6] \tag{8}$$

$$\text{newcrc}[7] = d[7] \wedge d[6] \wedge d[5] \wedge c[5] \wedge c[6] \wedge c[7] \tag{9}$$

The following examples show calculated CRC byte based off various input data:

I2C Data 00h : CRC = F3h

I2C Data FFh : CRC = 00h

I2C Data 80h : CRC = 7Ah

I2C Data 4Ch : CRC = 10h

I2C Data E0h : CRC = 5Dh

I2C Data 00000000h : CRC = D1h

I2C Data FFFFFFFFh : CRC = 0Fh

6.5.2 Data Definition

6.5.2.1 Magnetic Sensor Data

The X, Y, and Z magnetic sensor data are stored in 16-bit 2's complement in _Result_MSB and _Result_LSB registers for the corresponding channel. 16-bit X, Y, Z Magnetic Sensor Data Format shows example data out for X_Result[15:0]. For the table, three decimal places are used in the calculation. The data format is the same for Y_Result[15:0] and Z_Result[15:0]. The LSB size for each magnetic range is:

- 40mT: 1.19047619µT/LSB
- 80mT: 2.380952381µT/LSB
- 120mT: 273LSB/mT
- 240mT: 241LSB/mT

Table 6-7. 16-Bit X, Y, Z Magnetic Sensor Data Format

Magnetic Field (mT)				X_Result[15:0]	
Range = 40mT	Range = 80mT	Range = 120mT	Range = 240mT	BINARY	HEX
−39.009	−78.019	−120.029	−239.182	1000 0000 0000 0000	8000h
−19.504	−39.009	−60.014	−119.591	1100 0000 0000 0000	C000h
−0.001	−0.002	−0.003	−0.007	1111 1111 1111 1111	FFFFh
0	0	0	0	0000 0000 0000 0000	0000h
0.001	0.002	0.003	0.007	0000 0000 0000 0001	0001h
19.504	39.009	60.014	119.591	0100 0000 0000 0000	4000h
39.008	78.016	120.025	239.175	0111 1111 1111 1111	7FFFh

6.5.2.2 Temperature Sensor Data

The TMAG3001 measures temperature and store the value in the Temp_Result[15:0] field of the T_Result_MSB and T_Result_LSB registers. 16-bit Temperature Data Format shows the sensor output stored in a 16-bit 2's complement format in two 8-bit registers. For the table, only three decimal places are used in the calculations. The data can be retrieved as 16-bit format combining both MSB and LSB registers, or as 8-bit format through the MSB register.

Use Equation 10 to calculate the measured temperature in degree Celsius for 16-bit data, and use Equation 11 to calculate the measured temperature in degree Celsius for 8-bit data.

$$T = T_{SENS\_T0} + \frac{Temp\_Result[15:0] - T_{ADC\_T0}}{T_{ADC\_RES}} \qquad (10)$$

where

- T is the measured temperature in degree Celsius.
- T_{SENS_T0} is 25°C
- T_{ADC_RES} is 58.2 LSB/°C
- T_{ADC_T0} is 17512
- Temp_Result[15:0] is the decimal value the temperature registers

$$T = T_{SENS\_T0} + \frac{256 \times \left(T_{ADC\_T} - \frac{Temp\_Result[15:8]}{256}\right)}{T_{ADC\_RES}} \qquad (11)$$

Table 6-8. 16-Bit Temperature Data Format

TEMPERATURE (°C)	Temp_Result[15:0]	
	BINARY	**HEX**
–40	0011 0101 1010 0001	35A1h
–25	0011 1001 0000 1010	390Ah
0	0011 1110 1011 1001	3EB9h
25	0100 0100 0110 1000	4468h
25.02	0100 0100 0110 1001	4469h
85	0101 0001 1111 1100	520Ch
125	0101 1011 0000 1100	5B0Ch

6.5.2.3 Magnetic Sensor Gain Correction

The TMAG3001 enables gain correction for one of the magnetic axes if needed. Table 6-9 shows the register configuration to set magnetic gain. MAG_GAIN_CH and ANGLE_EN[1:0] bits are used to set the specific magnetic channel that can be configured for gain modification. The Sensor_Config_4 register is used to store the Gain_Config to be corrected in 8 bit value.

Table 6-9. Register Field Settings to Configure for Magnetic Gain Correction

Register Name	Register alias when ANGLE_EN=1b and THR_SEL = 00 or 01 or 11b	Description
Sensor_Config_4	Gain_Config[7:0]	Configure the gain of one of the magnetic channels as defined by MAG_GAIN_CH and ANGLE_EN[1:0] values of Sensor_Config_2 register

The Gain_Config[7:0] is a direct multiplier to the measured magnetic field with a value between 0 and 1. The LSB size of Gain_Config[7:0] is 0.00390625. For example, if the field measured by the TMAG3001 was 20mT and a Gain_Config[7:0] setting of 80h was used, a gain setting of 0.5, the resultant value of X_Result is 10mT.

Table 6-10. 1-Bit Gain_Config Data Format

Gain (mT/mT)	Gain_Config[7:0]	
	BINARY	**HEX**
0	0000 0000	00h
0.00390625	0000 0001	01h
0.25	0100 0000	40h
0.5	1000 0000	80h
0.75	1100 0000	C0h
0.99609375	1111 1111	FFh

As an example, Figure 6-26 shows the amplitude of a corrected magnetic field using the Gain_Config[7:0] register settings. The selection and order of the sensors are defined in the ANGLE_EN[1:0] register bits setting. The gain correction for the selected channel is disabled if the Gain_Config[7:0] registers are set to 00h.
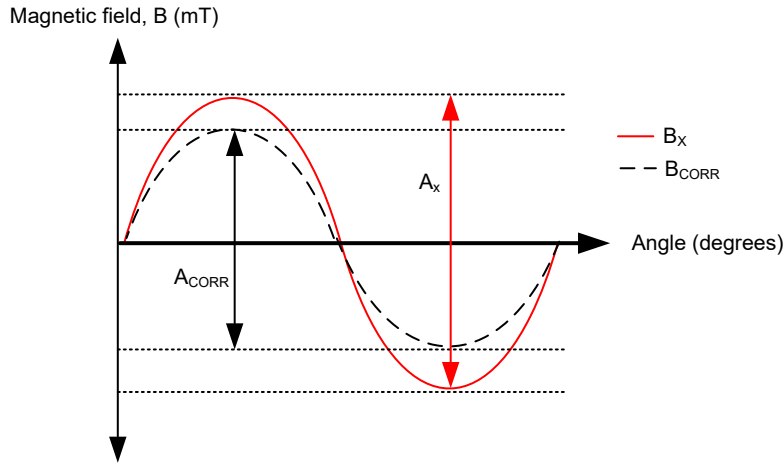
Figure 6-26. Magnetic Sensor Data Gain Correction

6.5.2.4 Magnetic Sensor Offset Correction

The TMAG3001 enables offset correction for a pair of magnetic axes.

Table 6-11. Register Field Settings to Configure for Magnetic Offsets

Register Name	Register alias when ANGLE_EN[1:0] = 1h or 2h or 3h. Or THR_SEL[1:0] = 0h or 1h or 3h	Description
Sensor_Config_5	Offset_Config_1	Sets the offset for first channel
Sensor_Config_6	Offset_Config_2	Sets the offset for second channel

The offset correction is stored in 8-bit 2's complement format. 8-bit Magnetic Sensor Offset Correction Data Format shows example offset for Offset_Config_x where x can be the first or second channel. For the table, only three decimal places are shown. The data format is the same for Offset_Config_1[7:0] and Offset_Config_2[7:0]. The LSB size for each magnetic range is:

- 40mT: 51.2LSB/mT
- 80mT: 25.6LSB/mT
- 120mT: 15.3985LSB/mT
- 240mT: 7.70LSB/mT

Table 6-12. 8-Bit Magnetic Sensor Offset Correction Data Format.

Magnetic Offset (mT)				Offset_Config_x[7:0]	
Range = 40mT	Range = 80mT	Range = 120mT	Range = 240mT	BINARY	HEX
−2.5	−5	−8.313	−16.625	1000 0000	80h
−1.992	−3.984	−6.624	−13.248	1001 1010	9Ah
−0.019	−0.039	−0.065	−0.130	1111 1111	FFh
0	0	0	0	0000 0000	00h
0.019	0.039	0.065	0.130	0000 0001	01h
1.992	3.984	6.624	13.248	0110 0110	66h
2.480	4.961	8.248	16.495	0111 1111	7Fh

As an example, if the uncorrected waveform for a particular axis has a value that is offset by 2mT, enter the offset correction value of −2mT in the corresponding Offset_Config_x[7:0] bit field. This value is added to the measured field before (or after) any gain setting is applied. The selection and order of the sensors are defined in the ANGLE_EN register bits setting. The default value of these offset correction registers are set as zero, when offset correction is enabled.

6.5.2.5 Angle and Magnitude Data Definition

The TMAG3001 calculates the angle from a pair of magnetic axes based off the Angle_EN[1:0] setting. The 13-bit Angle_Result[12:0] value is stored in the Angle_Result_MSB and Andle_Result_LSB registers. The data format is an unsigned angle value with LSB size of 0.0625°. The table below shows example angle values.

Table 6-13. 13-Bit Angle Data Format

ANGLE (°)	Angle_Result[12:0]	
	BINARY	HEX
0	0 0000 0000 0000	0000h
0.0625	0 0000 0000 0001	0001h
90	0 0101 1010 0000	05A0h
180	0 1011 0100 0000	0B40h
270	1 0000 1110 0000	10E0h
360	1 0110 1000 0000	1680h

During the angle calculation, the Magnitude_Result[7:0] stores the resultant vector magnitude in the Magnitude_Result register. Magnitude_Result[7:0] is an unsigned value with a LSB size that depends on the range of device. For the table below, only 3 decimal places are shown.

- 40mT: 3.281LSB/mT
- 80mT: 1.640LSB/mT
- 120mT: 1.066LSB/mT
- 240mT: 0.535LSB/mT

For on-axis angular measurement, the magnitude value must remain constant across the full 360° measurement.

Table 6-14. 8-Bit Magnitude Data Format

Magnitude (mT)				Magnitude_Result7:0]	
Range = 40mT	Range = 80mT	Range = 120mT	Range = 240mT	BINARY	HEX
0	0	0	0	0000 0000	00h
0.304	0.609	0.937	1.868	0000 0001	01h
4.571	9.142	14.065	28.029	0000 1111	0Fh
37.7904	75.580	116.278	231.708	0111 CC00	7Ch
77.714	155.428	239.120	476.496	1111 1111	FFh

6.5.2.6 Angle Offset Correction

The TMAG3001 enables offset correction for a pair of magnetic axes to set a zero reference to compensate for the magnet placement errors after installation. The THR_CONFIG_3 register stores the offset values. The default value of these offset correction registers are set as zero. To enable the angle offset correction, Angle_Offset_EN bit is set to 1h. The selection and order of the sensors are defined in the Angle_EN[1:0] register bits setting. The Angle_Offset_DIR provides the ability to add or subtract the angle offset value. The TMAG3001 provides the ability to correct the angle offset by ±255 degrees with a resolution of 1°/LSB.

Table 6-15. Register Field Settings to Configure for Angle Offset Correction

Register Name	Register alias when THR_SEL[1:0] =1h, or 3h	Description
THR_Config_3	Angle_Offset[7:0]	Adds an angle offset to Angle_Result[12:0]. The resolution of the angle offset is 1 degree.

Table 6-16. 8-Bit Angle Offset Data Format

ANGLE (°)	Angle_Offset[7:0]	
	BINARY	HEX
0	0000 0000	00h
1	0000 0001	01h
90	0101 1010	5Ah
180	1011 0100	B4h
255	1111 1111	FFh

7 Application and Implementation

> **Note**
>
> Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

7.1.1 Select the Sensitivity Option

The TMAG3001 comes in two sensitivity options A1 and A2. Select the highest TMAG3001 sensitivity option that can measure the required range of magnetic flux density so that the ADC input range is maximized.

Larger-sized magnets and farther sensing distances can generally enable better positional accuracy than very small magnets at close distances, because magnetic flux density increases exponentially with the proximity to a magnet.

7.1.2 Temperature Compensation for Magnets

The TMAG3001 temperature compensation is designed to directly compensate the average temperature drift of several magnets as specified in the MAG_TEMPCO register bits. The residual induction (B_r) of a magnet typically reduces by 0.12%/°C for NdFeB, and 0.20%/°C for ferrite magnets as the temperature increases. Set the MAG_TEMPCO bit to default 00b if the device temperature compensation is not needed.

Product Folder Links: *TMAG3001*

7.1.3 Sensor Conversion

Multiple conversion schemes can be adopted based off the MAG_CH_EN and CONV_AVG register bits settings.

7.1.3.1 Continuous Conversion

The TMAG3001 can be set in continuous conversion mode when Operating_Mode[1:0] is set to 2h. Figure 7-1 shows few examples of continuous conversion. The input magnetic field is processed in two steps. In the first step the device spins the hall sensor elements, and integrates the sampled data. In the second step the ADC block converts the analog signal into digital bits and stores in the corresponding result register. While the ADC starts processing the first magnetic sample, the spin block can start processing another magnetic sample. In this mode the temperature data is taken at the beginning of each new conversion. This temperature data is used to compensate for the magnetic thermal drift.
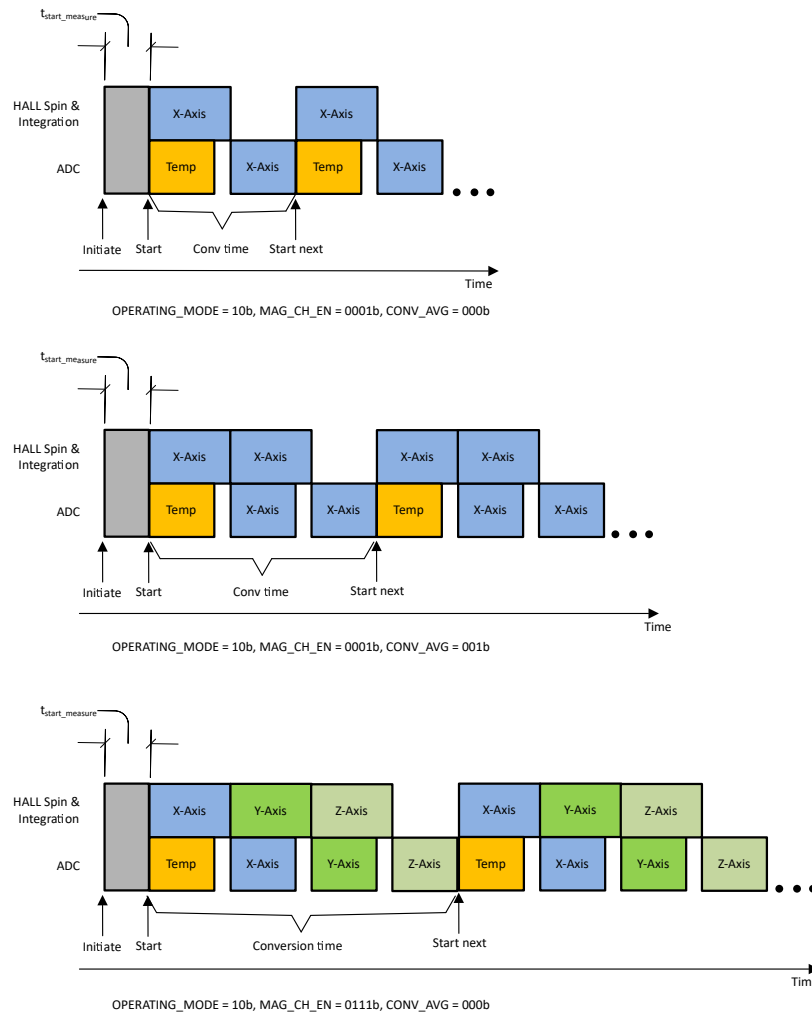
Figure 7-1. Continuous Conversion Examples

7.1.3.2 Trigger Conversion

The TMAG3001 supports trigger conversion with Operating_Mode[1:0] set to 0h. The trigger event can be initiated through I^{2}C command or $\overline{\text{INT}}$ signal. Figure 7-2 shows an example of trigger conversion with temperature, X, Y, and Z sensors activated.
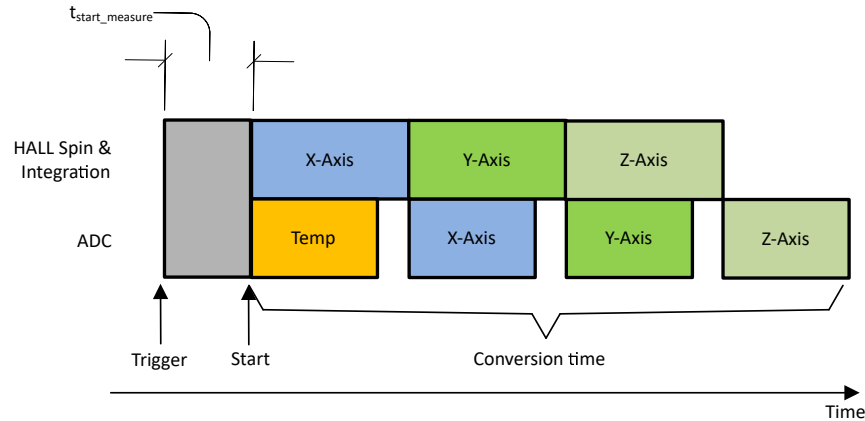
Figure 7-2. Trigger Conversion for Temperature, X, Y, and Z Sensors

7.1.3.3 Pseudo-Simultaneous Sampling

In absolute angle measurement, application sensor data from multiple axes are required to calculate an accurate angle. The magnetic field data collected at different times through the same signal chain introduces error in angle calculation. The TMAG3001 offers pseudo-simultaneous sampling data collection modes to eliminate this error. Figure 7-3 shows an example where MAG_CH_EN is set at Bh to collect XZX data. Equation 12 shows that the time stamps for the X and Z sensor data are the same.

$$t_Z = \frac{t_{X1} + t_{X2}}{2} \tag{12}$$

where

- t_{X1}, t_Z, t_{X2} are time stamps for X, Z, X sensor data completion as defined in Figure 7-3.
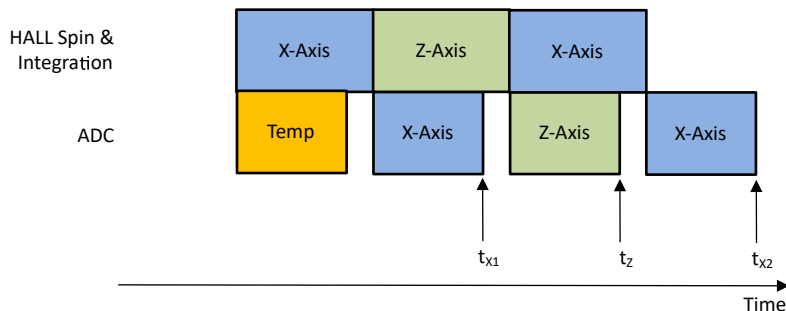
Figure 7-3. XZX Magnetic Field Conversion

The vertical X, Y sensors of the TMAG3001 exhibit more noise than the horizontal Z sensor. The pseudo-simultaneous sampling can be used to equalize the noise floor when two set of vertical sensor data are collected against one set of horizontal sensor data, as in examples of XZX or YZY modes.

7.1.4 Magnetic Limit Check

The TMAG3001 enables magnetic limit checks for single or multiple axes at the same time. The device can be configured to be sensitive for X, Y and Z magnetic axes thresholds when THR_SEL[1:0] is set to 2h.

Table 7-1. Register Configuration for Magnetic Limit Check When THR_SEL[1:0] = 1h

Register Name	Register alias when THR_SEL[1:0] = 1h	Description
THR_Config_1	X_THR_LO	Sets the lower threshold limit for X channel
THR_Config_2	Y_THR_LO	Sets the lower threshold limit for Y channel
THR_Config_3	Z_THR_LO	Sets the lower threshold limit for Z channel

Table 7-2. Register Configuration for Magnetic Limit Check When THR_SEL[1:0] = 2h and Angle_EN[1:0] = 0h

Register Name	Register alias when THR_SEL[1:0] = 2h and Angle_EN[1:0] = 0h	Description
Sensor_Config_4	X_THR_HI	Sets the upper threshold limit for X channel
Sensor_Config_5	Y_THR_HI	Sets the upper threshold limit for Y channel
Sensor_Config_6	Z_THR_HI	Sets the upper threshold limit for Z channel

The magnetic higher and lower thresholds are 8-bit, 2's complement numbers, with the possible range of threshold entrees to be ±128. Both the higher and lower threshold limits can be enabled independently. No threshold comparison is done if the thresholds are set to 0h. The lower threshold for X channel can be calculated using Equation 13.

$$\text{Threshold}\left(\text{mT}\right) = \frac{\text{THR\_CONFIG\_1}}{128} \times \text{Magnetic Range} \times \left(1 + \text{X\_Y\_RANGE}\right) \tag{13}$$

For example, for the A1 device version, the default magnetic range is ±40mT. If X_Y_RANGE=0 and THR_SEL= 10b, for a threshold configuration of 0000111b in THR_CONFIG_1, the X channel lower threshold is given by

$$\text{X Low Threshold}\left(\text{mT}\right) = \frac{7}{128} \times 40\text{ mT} = 2.1875\text{ mT} \tag{14}$$

Figure 7-5 and Figure 7-5 show examples of magnetic limit cross detection events while the field going above, below, exiting a magnetic band, and entering a magnetic band. The device keeps generating an interrupt with each new conversion if the magnetic fields remain in the shaded regions in the figures. The MAG_THR_DIR register bit helps select the out of range regions for threshold crossings. The magnetic limit check can be performed in standby, continuous or wake and sleep operating modes.
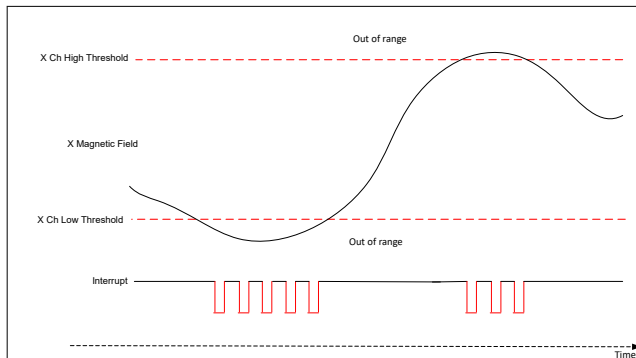
Figure 7-4. Magnetic Limit Cross Check With MAG_THR_DIR = 0h, THR_SEL[1:0] = 2h, INT_STATE = 1h
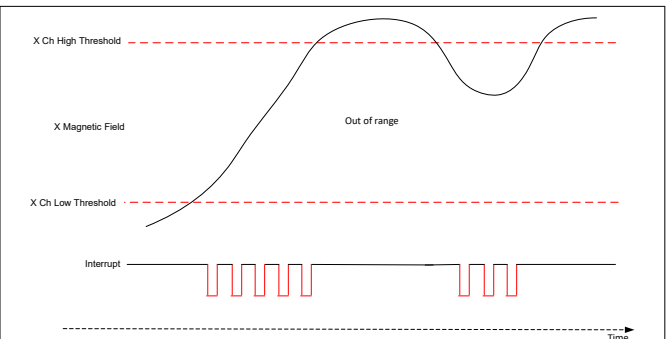
Figure 7-5. Magnetic Lower Limit Cross Check With MAG_THR_DIR =1b, THR_SEL=10b , INT_STATE=1b

7.1.5 Magnitude Limit Check

The TMAG3001 enables magnitude limit checks when the part is configured to calculate an angle using ANGLE_EN. The magnitude of the absolute magnetic field is stored in the Magnitude_Result register. The device can be configured to be configured for magnitude threshold checks when THR_SEL[1:0] is set to 3h. Register Configuration for Magnitude Limit Check shows the configuration of registers to enable magnetic limit checks.

Table 7-3. Register Configuration for Magnitude Limit Check

| Register Name	Register alias when THR_SEL[1:0] = 3h	Description
THR_Config_1	M_THR_LO	Sets the lower threshold limit for magnitude check
THR_Config_2	M_THR_HI	Sets the higher threshold limit for the magnitude check

The magnitude higher and lower thresholds are 8-bit numbers, with the possible range of threshold entries from 0 to 255. Both the higher and lower threshold limits can be enabled independently. No threshold comparison is done if the thresholds are set to 0h.

Figure 7-7 and Figure 7-6 show examples of magnitude limit cross detection events while the field going above, below, exiting a magnetic band, and entering a magnetic band. The device keeps generating an interrupt with each new conversion if the magnetic fields remain in the shaded regions in the figures. The MAG_THR_DIR register bit helps select the out of range regions for threshold crossings. The magnitude limit check can be performed in standby, continuous or wake and sleep operating modes.

Figure 7-6. Magnitude Limit Cross Check With MAG_THR_DIR = 0h, THR_SEL[1:0] = 3h, INT_State = 1h

Figure 7-7. Magnitude Limit Cross Check With MAG_THR_DIR = 1h, THR_SEL[1:0] = 3h, INT_State = 1h
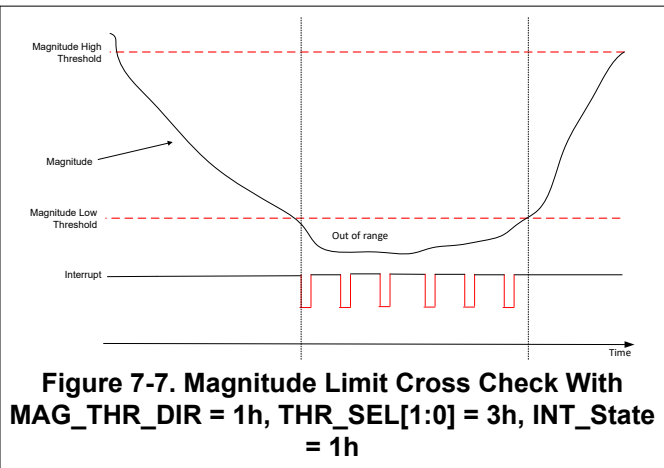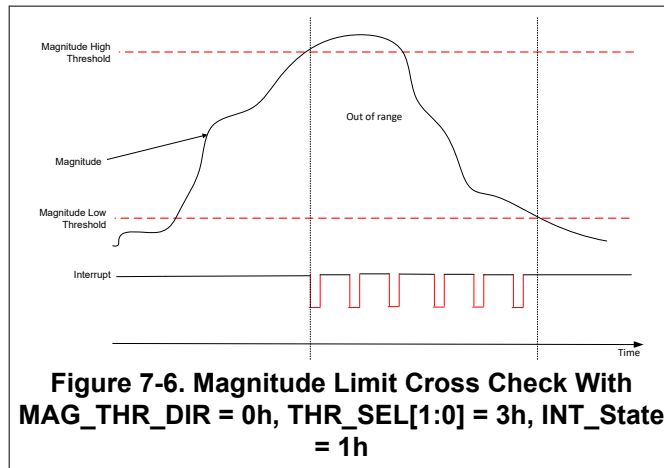
7.1.6 Angle Limit Check

The TMAG3001 features an integrated angle calculation so the device can be used as an angle switch for any two axes set by ANGLE_EN. The device can be configured to be sensitive for angle thresholds when THR_SEL[1:0] is set to 1h. When THR_SEL[1:0] is set to 1h, the THR_Config_1 register acts as A_THR_REF and THR_Config_2 acts as A_THR_BAND. The Angle limit checks can be configured using the angle threshold reference set by A_THR_REF and the threshold band set by the A_THR_BAND. The reference angle threshold, A_THR_REF is absolute angle coded on 8 bits (as shown in table), with a resolution of 2 degrees per LSB and a maximum range of 360 degrees. A_THR_BAND is also absolute angle coded on 8 bits and has a resolution of 1 degree per LSB, with a maximum range of up to 180 degrees.

Table 7-4. Register Configuration for Angle Limit Check

Register Name	Register alias when THR_SEL[1:0] = 1h	Description
THR_Config_1	A_THR_REF	Sets the angle threshold reference
THR_Config_2	A_THR_BAND	Sets the Threshold region around the reference
THR_Config_3	Angle_Offset[7:0]	Sets the user defined angle offset

Angle Limit Check and Angle Limit Cross Check show examples of angle limit cross detection events while the measured angle goes above or below, exiting an angle band, and entering an angle band. The device keeps generating an interrupt with each new conversion if the measured angle remains in the shaded regions in the figures. The MAG_THR_DIR register bit helps select the out of range regions for threshold crossings.

Figure 7-8. Angle Limit Check With MAG_THR_DIR = 0h, THR_SEL[1:0] = 1h, INT_STATE = 1h

Figure 7-9. Angle Limit Cross Check With MAG_THR_DIR =1b, THR_SEL=01b , INT_STATE=1b
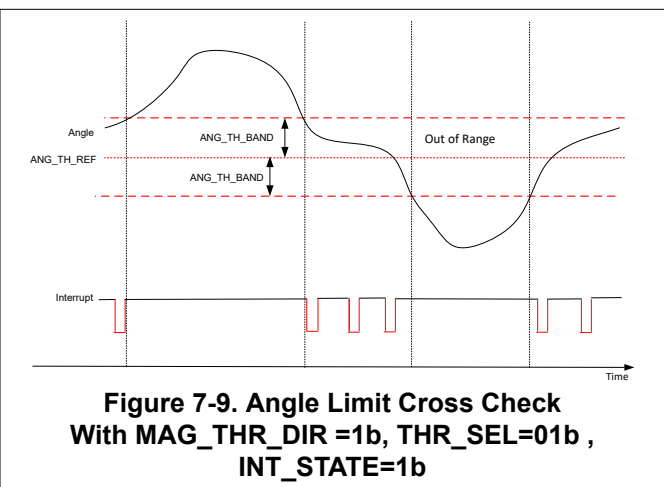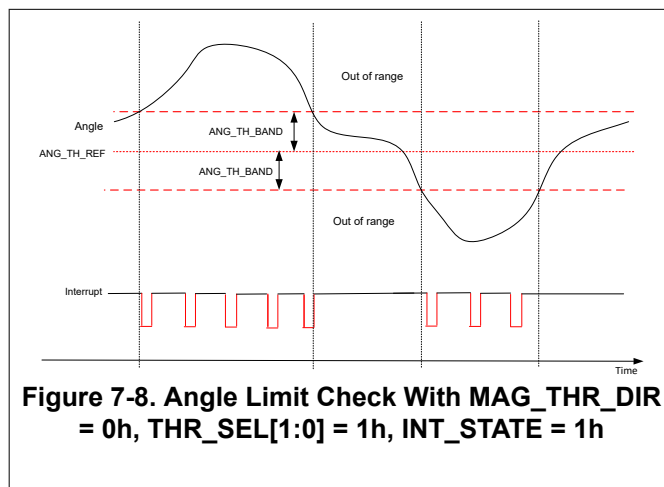
7.1.7 Switch Mode

The TMAG3001 supports flexible and configurable switch mode option on the $\overline{INT}$ pin. In this mode, the output pin is set to a level based output when a threshold crossing is detected. The device can be configured to be in switch mode in standby, active and wake up and sleep power modes. If the device is configured in switch mode, $\overline{INT}$ pin cannot be used to trigger the conversions or be used as an output for any other purposes. The device the supports unipolar and omnipolar switch mode options based on the configured thresholds. With the ability to set both upper and lower thresholds, TMAG3001 is also used for tamper detection where excessive magnetic fields need to be detected. With the ability to calculate angle across any two axes, the device has the ability to also be configured as an angle switch.

7.1.7.1 Unipolar Switch Mode

The TMAG3001 is sensitive to both positive and negative magnetic fields. the device can be configured to act as a switch that is sensitive to a single direction on any of the three axes. Figure 7-10 shows an example for unipolar switch mode where the Bop represents the operating point for the switch above which the $\overline{INT}$ pin switches to ON state. Brp, represents the reverse operating point, below which the $\overline{INT}$ pin returns to the OFF operating state. TMAG3001 enables the device to be used as a 3D magnetic switch when all the magnetic channels are enabled and when THR_SEL[1:0] bits are set to 2h. When used as a 3D magnetic switch, $\overline{INT}$ pin switches to ON state, if one of the magnetic channels crosses the operating point, set by the low thresholds that can be configured in THR_Config1, THR_Config2 and THR_Config3. The hysteresis for the switch mode is set using the THR_HYST bits. The switch turns to an off position only if the measurements of all the enabled magnetic channels fall below the reverse operating point, Brp.
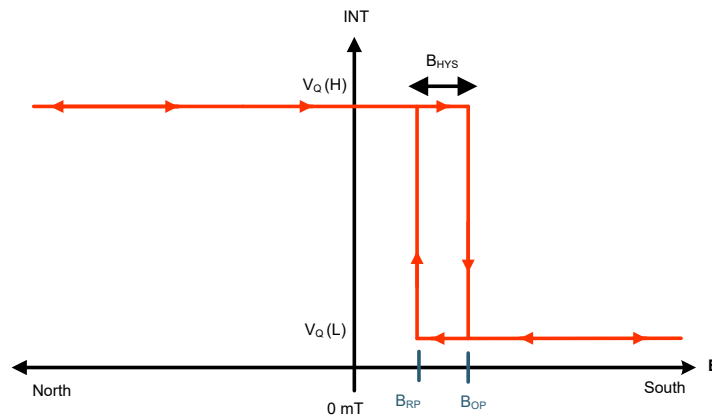
Figure 7-10. Unipolar 3D Magnetic Switch

7.1.7.2 Omnipolar Switch Mode

Figure 7-11 shows an example for the omnipolar switch mode where the device is sensitive to either the positive or negative thresholds. The omnipolar switch mode is particularly useful in cases where the magnet polarity is not controlled during the manufacturing process. In this mode, the same thresholds are used for both the polarities. B_{OP} represents the operating point for the switch above which the $\overline{INT}$ pin switches states. B_{RP}, represents the reverse operating point, below which the $\overline{INT}$ pin returns to the previous operating state. This mode is similar to unipolar switch mode.
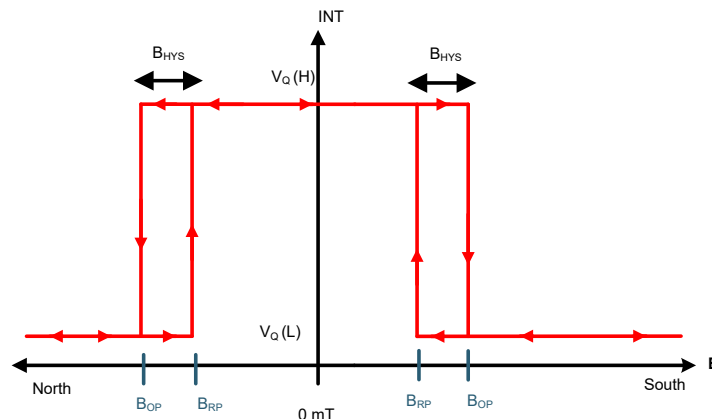
Figure 7-11. Omnipolar Switch Mode

Product Folder Links: *TMAG3001*

7.1.7.3 Tamper Detection

The TMAG3001 features both the high and low thresholds for individual axes. The device can be used to detect higher than expected magnetic fields by configuring the corresponding high thresholds for X, Y and Z axes. When THR_SEL[1:0] bits are set 2h, the Sensor_Config_4, Sensor_Config_5,Sensor_Config_6 registers are used to set the higher thresholds (B_{TAMPER}) for X, Y and Z axes respectively.

When the device is configured in switch mode, the higher thresholds must be set in the same polarity. The TMAG3001 can be used to detect high magnetic fields on all three axes when all the magnetic channels are enabled. Figure 7-12 shows the unipolar switch mode with higher thresholds configured for the magnetic channels. Figure 7-13 shows the tamper detection feature when the device is configured in the omnipolar switch mode. In the omnipolar switch mode, the sign bit for the thresholds are ignored.
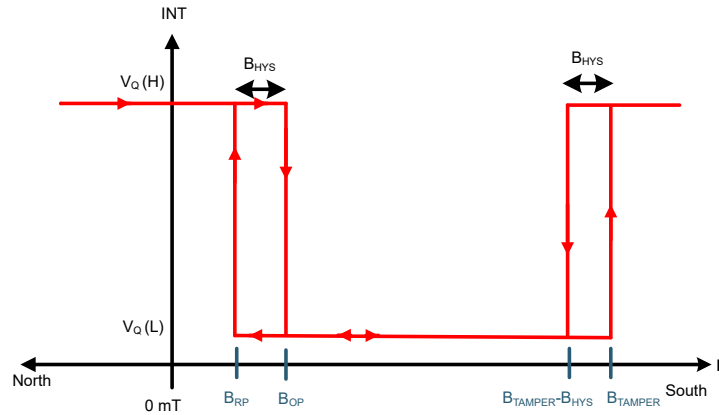
Figure 7-12. Unipolar Switch Mode Showing Tamper Detection
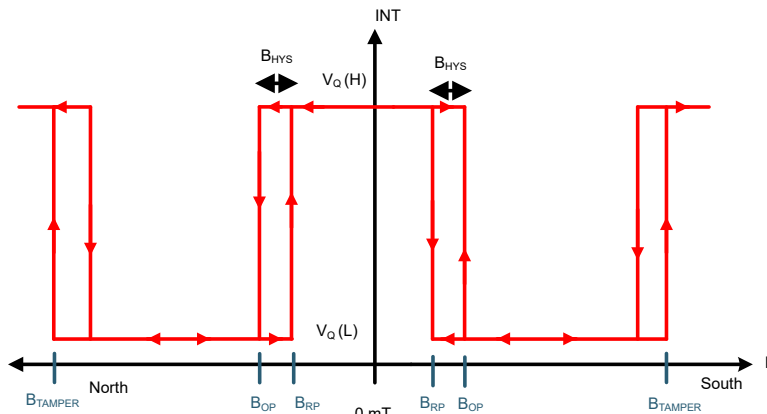
Figure 7-13. Omnipolar Switch Mode Showing Tamper Detection

7.1.7.4 Angle Switch

The TMAG3001 features an integrated angle calculation so the device can be used as an angle switch for any two axes set by ANGLE_EN. The device is configured as an angle switch, when INT_Mode[2:0] is set to 5h. The THR_Config_1 register acts as A_TH_REF, that sets the reference threshold for the angle crossing. The THR_Config_2 register acts as A_TH_BAND, that determines the threshold region for the angle crossing detection. Figure 7-14 shows the response of the device where the switch output is set to ON state and when the measured angle is above the $\theta_{TH\_REF} + \theta_{TH\_BAND}$ or below $\theta_{TH\_REF} + \theta_{TH\_BAND}$. The switch output is set to OFF state if the switch output crosses below the hysteresis value set by θ_{ANG_HYS}. Figure 7-15 shows the response of the device, based on the configured thresholds and hysteresis.
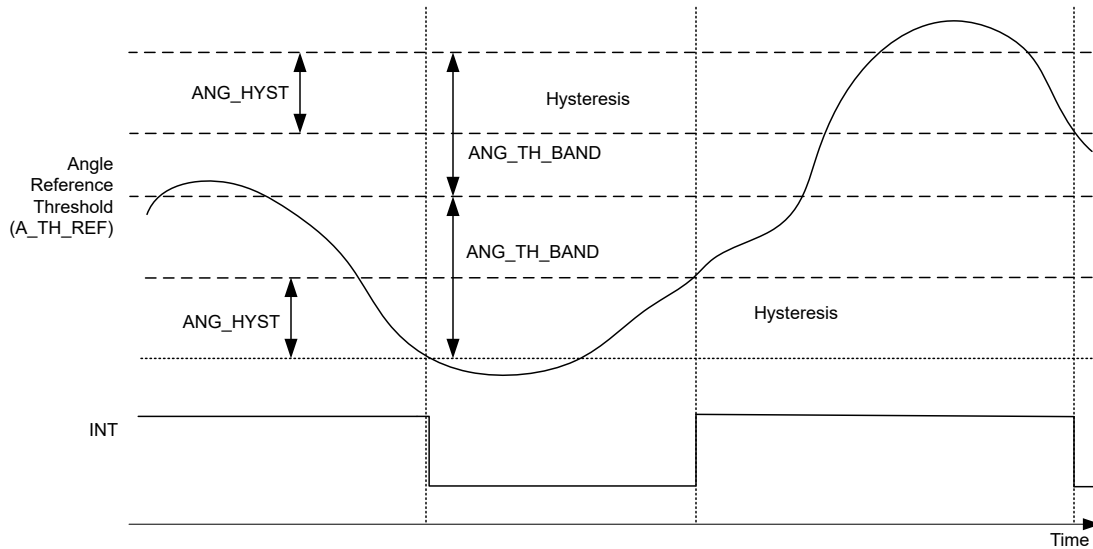
Figure 7-14. Timing Diagram Showing the Angle Switch Operation, THR_SEL[1:0] = 1h, INT_Mode[2:0] = 5h

Figure 7-15. Angle Switch

Product Folder Links: *TMAG3001*
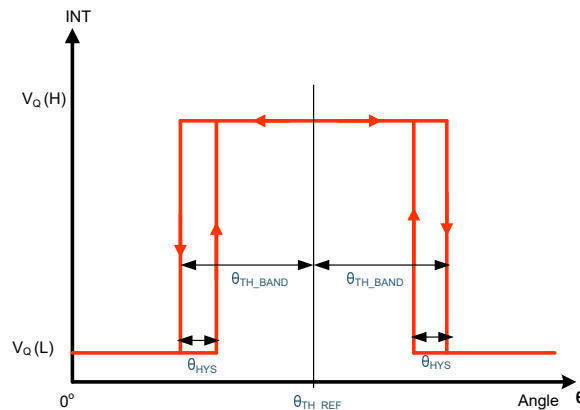
7.1.7.5 Magnitude Switch (Button Press Detection)

The TMAG3001 features an integrated CORDIC that enables to calculate the absolute magnitude of the two fields as set by ANGLE_EN. For angle applications, where the magnet is placed on top of the sensor, a button press event can be detected only by using the absolute magnetic field as given by the Magnitude_Resultt register. The magnitude varies exponentially with respect to the airgap between the magnet and the sensor and hence during a button press event, the magnitude of the magnetic field goes higher. The device can be configured to be sensitive for magnitude thresholds when THR_SEL[1:0] is set to 3h. The device is configured as a magnitude switch, when INT_Mode[2:0] is set to 5h. The magnitude of the magnetic field is always positive, therefore the device does not support the magnitude switch mode, when the INT_Mode[2:0] is set to 6h (omnipolar mode). Figure 7-17 shows the response of the device, where the switch output is set to ON state, when the measured angle is above the MAG_HI and the switch output is set to OFF state, when the measured magnitude is below MAG_LO, the low threshold. The lower threshold for the magnitude, |BMAG,LO| is configured using the THR_Config_1 register and the higher threshold for the magnitude, |BMAG,HI| is configured using the THR_Config_2 register.
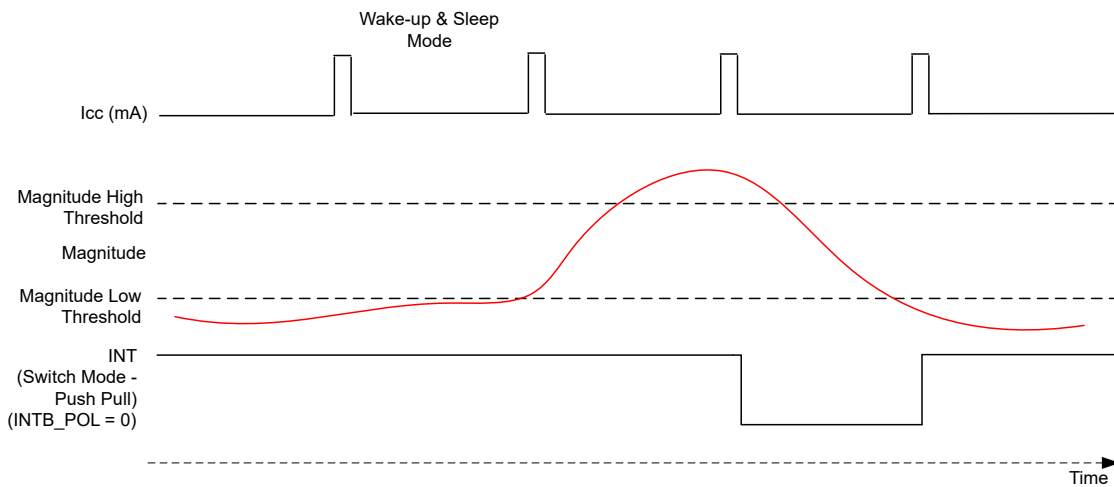
Figure 7-16. Timing Diagram Showing the Magnitude Switch Operation, THR_SEL[1:0] = 3h, INT_Mode[2:0] = 5h
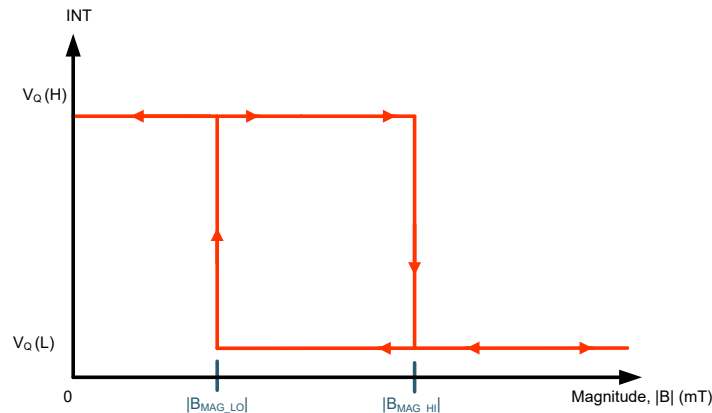
Figure 7-17. Magnitude Switch

7.1.8 Error Calculation During Linear Measurement

The TMAG3001 offers independent configurations to perform linear position measurements in X, Y, and Z axes. To calculate the expected error during linear measurement, the contributions from each of the individual error sources must be understood. The relevant error sources include sensitivity error, offset, noise, cross axis sensitivity, hysteresis, nonlinearity, drift across temperature, drift across life time, and so forth. For a 3-axis

Hall solution like the TMAG3001, the cross-axis sensitivity and hysteresis error sources are insignificant. Use Equation 15 to estimate the linear measurement error calculation at room temperature.

$$Error_{LM\_25C} = \frac{\sqrt{(B \times SENS_{ER})^2 + B_{off}^2 + N_{RMS\_25}^2}}{B} \times 100\% \qquad (15)$$

where

- $Error_{LM\_25C}$ is total error in % during linear measurement at 25°C.
- B is input magnetic field.
- $SENS_{ER}$ is sensitivity error in decimal number at 25°C. As an example, enter 0.05 for sensitivity error of 5%.
- B_{off} is offset error at 25°C.
- N_{RMS_25} is RMS noise at 25°C.

In many applications, system level calibration at room temperature can nullify the offset and sensitivity errors at 25°C. The noise errors can be reduced by internally averaging by up to 32x on the device in addition to the averaging that can be done in the microcontroller. Use Equation 16 to estimate the linear measurement error across temperature after calibration at room temperature.

$$Error_{LM\_Temp} = \frac{\sqrt{(B \times SENS_{DR})^2 + B_{off\_DR}^2 + N_{RMS\_Temp}^2}}{B} \times 100\% \qquad (16)$$

where

- $Error_{LM\_Temp}$ is total error in % during linear measurement across temperature after room temperature calibration.
- B is input magnetic field.
- $SENS_{DR}$ is sensitivity drift in decimal number from value at 25°C. As an example, enter 0.05 for sensitivity drift of 5%.
- B_{off_DR} is offset drift from value at 25°C.
- N_{RMS_Temp} is RMS noise across temperature.

If room temperature calibration is not performed, sensitivity and offset errors at room temperature must also account for total error calculation across temperature (see Equation 17).

$$Error_{LM\_Temp\_NCal} = \frac{\sqrt{(B \times SENS_{ER})^2 + (B \times SENS_{DR})^2 + B_{off}^2 + B_{off\_DR}^2 + N_{RMS\_Temp}^2}}{B} \times 100\% \qquad (17)$$

where

- $Error_{LM\_Temp\_NCal}$ is total error in % during linear measurement across temperature without room temperature calibration.

Note

In this section, error sources such as system mechanical vibration, magnet temperature gradient, earth magnetic field, nonlinearity, lifetime drift, and so forth, are not considered. The user must take these additional error sources into account while calculating overall system error budgets.

7.1.9 Error Calculation During Angular Measurement

The TMAG3001 offers on-chip CORDIC to measure angle data from any of the two magnetic axes. The linear magnetic axis data can be used to calculate the angle using an external CORDIC as well. To calculate the expected error during angular measurement, the contributions from each individual error source must be understood. The relevant error sources include sensitivity error, offset, noise, axis-axis mismatch, nonlinearity, drift across temperature, drift across life time, and so forth. Use the Angle Error Calculation Tool to estimate the total error during angular measurement.

7.2 Typical Application

Magnetic 3D sensors are very popular due to contactless and reliable measurements, especially in applications requiring long-term measurements in rugged environments. The TMAG3001 offers design flexibility in wide range of industrial and personal electronics applications.

7.2.1 Angle Measurement

Magnetic angle sensors are very popular due to contactless and reliable measurements, especially in applications requiring long-term measurements in rugged environments. The TMAG3001 offers an on-chip angle calculator providing angular measurement based off any two of the magnetic axes. The two axes of interest can be selected in the ANGLE_EN register bits. The device offers angle output in complete 360 degree scale. Take several error sources into account for angle calculation, including sensitivity error, offset error, linearity error, noise, mechanical vibration, temperature drift, and so forth.
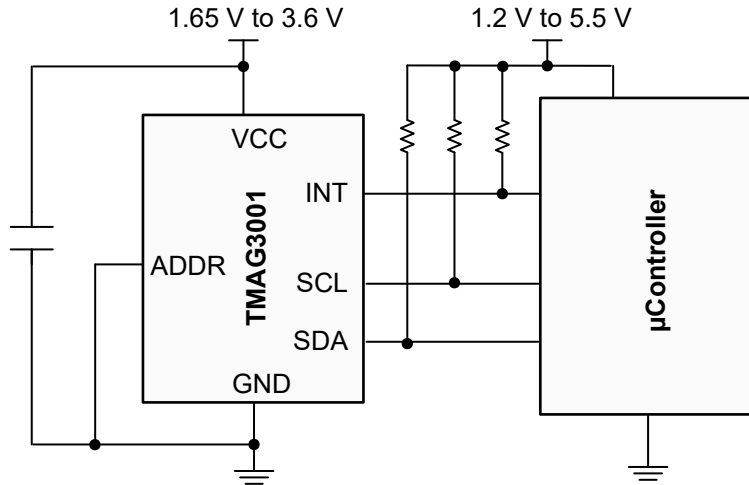
Figure 7-18. TMAG3001 Application Diagram for Angle Measurement

7.2.1.1 Design Requirements

Use the parameters listed in Table 7-5 for this design example.

Table 7-5. Design Parameters

DESIGN PARAMETERS	ON-AXIS MEASUREMENT	OFF-AXIS MEASUREMENT
Device	TMAG3001-A1	TMAG3001-A1
VCC	3.3V	3.3V
Device Position	Directly under the magnet	At the adjacent side of the magnet
Magnet	Cylinder: 4.7625mm diameter, 12.7mm thick, neodymium N52, Br = 1480	Cylinder: 4.7625mm diameter, 12.7mm thick, neodymium N52, Br = 1480
Magnetic Range Selection	Select the same range for both axes based off the highest possible magnetic field seen by the sensor	Select the same range for both axes based off the highest possible magnetic field seen by the sensor
RPM	<600	<600
Desired Accuracy	<2° for 360° rotation	<2° for 360° rotation

7.2.1.2 Detailed Design Procedure

For accurate angle measurement, the two axes amplitudes must be normalized by selecting the proper gain adjustment value in the MAG_GAIN_CONFIG register. The gain adjustment value is a fractional decimal number between 0 and 1. The following steps must be followed to calculate this fractional value:
• Set the device at 32x average mode and rotate the shaft full 360 degree.
• Record the two axes sensor ADC codes for the full 360 degree rotation.

- A normalized plot for the full 360 degree rotations are represented in Figure 7-20 or Figure 7-21.
- Measure the maximum peak-peak ADC code delta for each axis, A_X and A_Y.

- If $A_X > A_Y$, set the MAG_GAIN_CH register bit to 0b. Calculate the gain adjustment value for X axis: $$G_X = \frac{A_Y}{A_X}$$

- If $A_X < A_Y$, set the MAG_GAIN_CH register bit to 1b. Calculate the gain adjustment value for Y axis: $$G_Y = \frac{1}{G_X}$$
- The target binary gain setting at the GAIN_VALUE register bits are calculated from the equation, G_X or G_Y = GAIN_VALUE$_{decimal}$/ 256.

Example 1: If $A_X = A_Y = 60,000$, the GAIN_VALUE register bits are set at default 0000 0000b.

Example 2: If $A_X = 60,000$, $A_Y = 45,000$, the $G_X = 45,000/60,000 = 0.75$. Set MAG_GAIN_CH to 0b and GAIN_VALUE to 1100 0000b.

Example 3: If $A_X = 45,000$, $A_Y = 60,000$, the $G_X = (60,000/45,000) = 1.33$. $G_X > 1$, therefore the gain adjustment must be applied to Y axis with $G_Y = 1/G_X$. Set MAG_GAIN_CH to 1b and GAIN_VALUE to 1100 0000b.

7.2.1.2.1 Gain Adjustment for Angle Measurement

Common measurement topology include angular position measurements in on-axis or off-axis angular measurements shown in Figure 7-19. Select the on-axis measurement topology whenever possible as this offers the best optimization of magnetic field and the device measurement ranges. The TMAG3001 offers on-chip gain adjustment option to account for mechanical position misalignments.
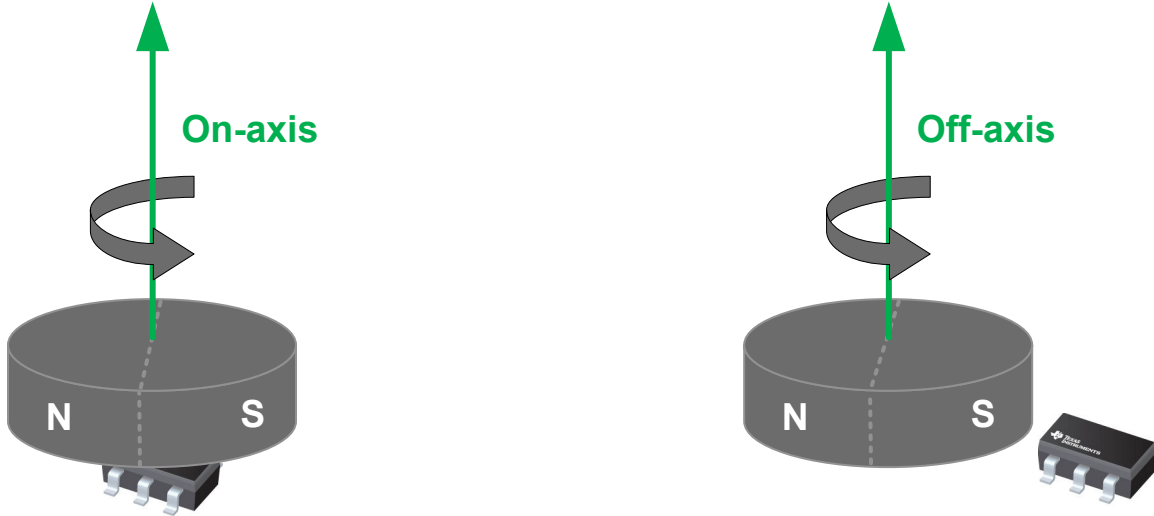
Figure 7-19. On-Axis vs Off-Axis Angle Measurements

7.2.1.3 Application Curves

Figure 7-20. X and Y Sensor Data for Full 360 Degree Rotation for On-Axis Measurement

Figure 7-21. X and Y Sensor Data for Full 360 Degree Rotation for Off-Axis Measurement
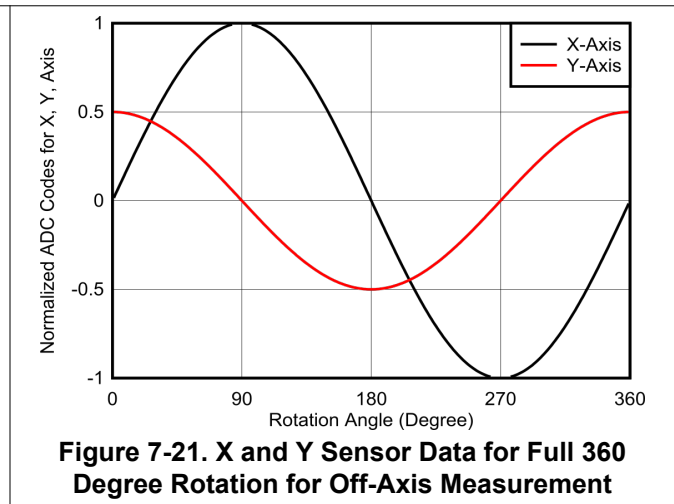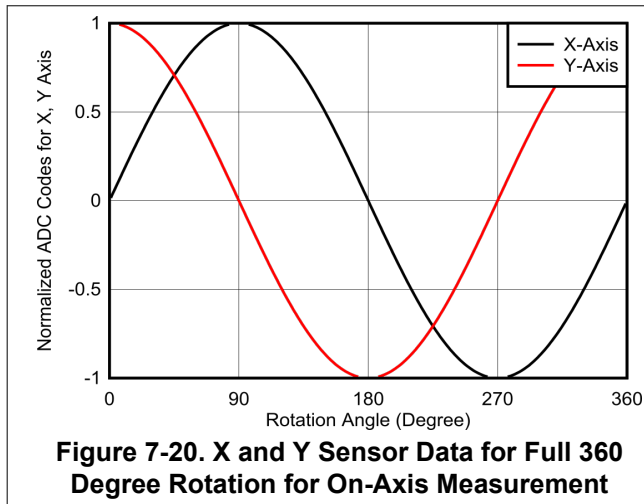
7.3 Best Design Practices

The TMAG3001 updates the result registers at the end of a conversion. I^{2}C read of the result register must be synchronized with the conversion update time to avoid reading a result data while the result register is being updated. For applications with tight timing budget use the $\overline{\text{INT}}$ signal to notify the controller when a conversion is complete.

7.4 Power Supply Recommendations

A decoupling capacitor close to the device must be used to provide local energy with minimal inductance. TI recommends using a ceramic capacitor with a value of at least 0.01µF.

7.5 Layout

7.5.1 Layout Guidelines

Magnetic fields pass through most nonferromagnetic materials with no significant disturbance. Embedding Hall effect sensors within plastic or aluminum enclosures and sensing magnets on the outside is common practice. Magnetic fields also easily pass through most printed circuit boards (PCBs), which makes placing the magnet on the opposite side of the PCB possible.

7.5.2 Layout Example

Figure 7-22. Layout Example With TMAG3001
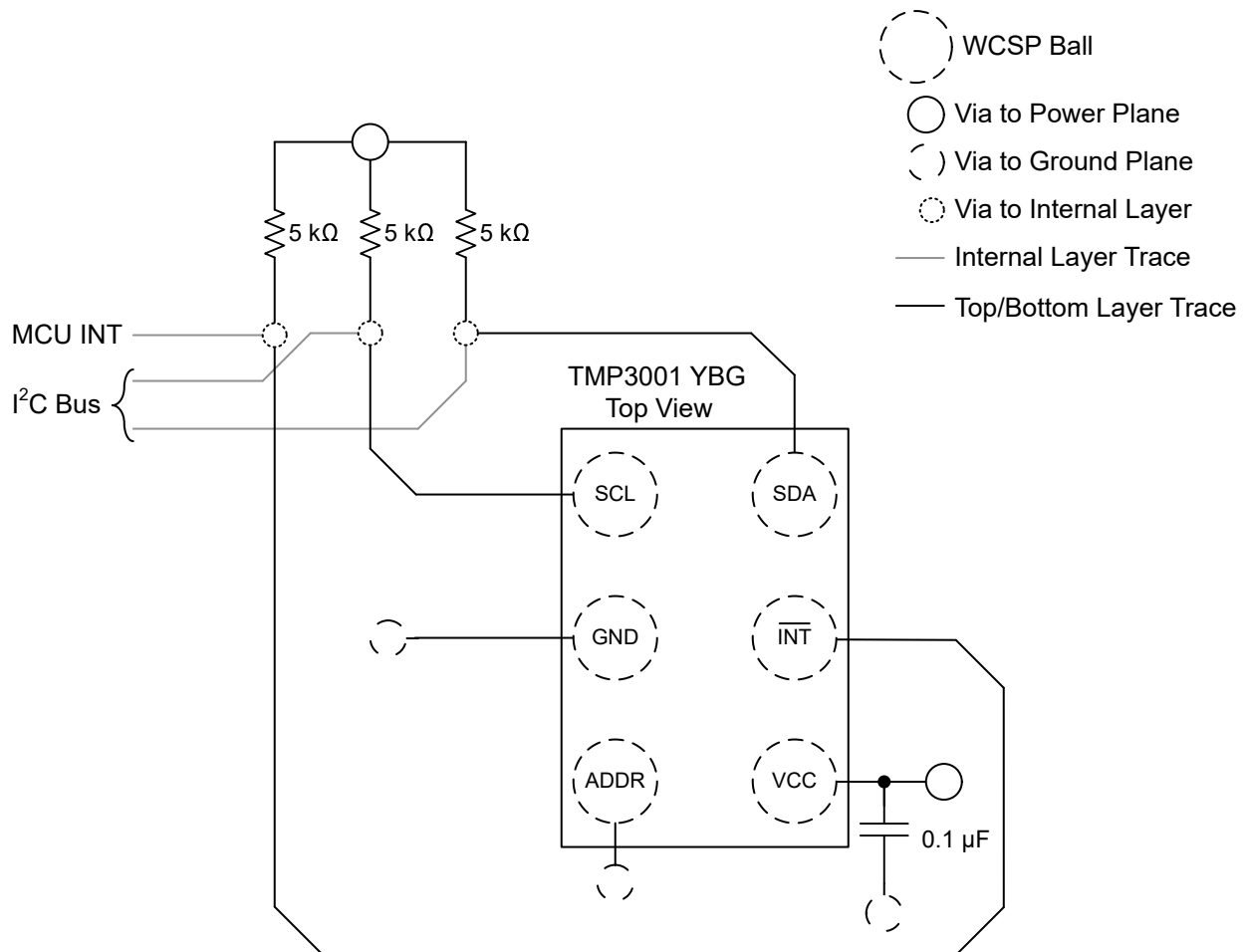
8 Register Map

Result and status register values are locked at the start of any I^{2}C transaction. If a conversion finishes during an I^{2}C transaction, the latest results are updated immediately after the STOP bit of that transaction.

Table 8-1. TMAG3001 Registers

ADDRESS	TYPE	RESET	ACRONYM	RESGISTER NAME	SECTION
0h	R/W	00h	Device_Config_1	Configure Device Operation Modes	Go
1h	R/W	00h	Device_Config_2	Configure Device Operation Modes	Go
2h	R/W	00h	Sensor_Config_1	Sensor Device Operation Modes	Go
3h	R/W	00h	Sensor_Config_2	Sensor Device Operation Modes	Go
4h	R/W	00h	THR_Config_1	Threshold Configuration	Go
5h	R/W	00h	THR_Config_2	Threshold Configuration	Go
6h	R/W	00h	THR_Config_3	Threshold Configuration	Go
7h	R/W	00h	Sensor_Config_3	Configure Device Operation Modes	Go
8h	R/W	00h	INT_Config_1	Configure Device Operation Modes	Go
9h	R/W	00h	Sensor_Config_4	Configure Device Operation Modes	Go
Ah	R/W	00h	Sensor_Config_5	Configure Device Operation Modes	Go
Bh	R/W	00h	Sensor_Config_6	Configure Device Operation Modes	Go
Ch	R/W	00h	I2C_Address	I2C Address Register	Go
Dh	R	0xh	Device_ID	ID for the device die	Go
Eh	R	49h	Manufacturer_ID_LSB	Manufacturer ID lower byte	Go
Fh	R	54h	Manufacturer_ID_MSB	Manufacturer ID upper byte	Go
10h	R	00h	T_Result_MSB	Conversion Result Register	Go
11h	R	00h	T_Result_LSB	Conversion Result Register	Go
12h	R	00h	X_Result_MSB	Conversion Result Register	Go
13h	R	00h	X_Result_LSB	Conversion Result Register	Go
14h	R	00h	Y_Result_MSB	Conversion Result Register	Go
15h	R	00h	Y_Result_LSB	Conversion Result Register	Go
16h	R	00h	Z_Result_MSB	Conversion Result Register	Go
17h	R	00h	Z_Result_LSB	Conversion Result Register	Go
18h	R	00h	Conv_Status	Conversion Status Register	Go
19h	R	00h	Angle_Result_MSB	Conversion Result Register	Go
1Ah	R	00h	Angle_Result_LSB	Conversion Result Register	Go
1Bh	R	00h	Magnitude_Result	Conversion Result Register	Go
1Ch	R	00h	Device_Status	Device_Diag Status Register	Go

Table 8-2. TMAG3001 Access Type Codes

Access Type	Code	Description
Read Type		
R	R	Read
Write Type		
W	W	Write
W1C	W 1C	Write 1 to clear
Reset or Default Value		
- *n*		Value after reset or the default value

Product Folder Links: *TMAG3001*

8.1 Device_Config_1 Register (Address= 0h) [Reset = 00h]

Device_Config_1 allows the configuration of CRC, magnetic tempco, averaging, and I2C read mode.

Return to Register Map.

Figure 8-1. Device_Config_1 Register

7	6	5	4	3	2	1	0
CRC_EN	MAG_Tempco[1:0]		Conv_AVG[2:0]			I2C_RD[1:0]	
R/W-0h	R/W-0h		R/W-0h			R/W-0h	

Table 8-3. Device_Config_1 Register Field Descriptions

Bit	Field	Type	Reset	Description
7	CRC_EN	R/W	0h	Enables I2C CRC byte to added to I2C read transactions 0h = CRC disabled 1h = CRC enabled
6-5	MAG_Tempco[1:0]	R/W	0h	Temperature Coefficient of Sense Magnet 0h = 0% (Current sensor applications) 1h = 0.12%/ deg C (NdBFe) 2h = 0.03% / deg C (SmCo) 3h = 0.2%/deg C (Ceramic)
4-2	Conv_AVG[2:0]	R/W	0h	Enables additional sampling of the sensor data to reduce the noise effect (or to increase resolution) 0h = 1x - 10.5 ksps (3-axes) or 22 ksps (1 axis) 1h = 2x - 5.9 ksps (3-axes) or 14.3 ksps (1 axis) 2h = 4x - 3.1 ksps (3-axes) or 8.3 ksps (1 axis) 3h = 8x - 1.6 ksps (3-axes) or 4.5 ksps (1 axis) 4h = 16x - 0.8 ksps (3-axes) or 2.4 ksps (1 axis) 5h = 32x - 0.4 ksps (3-axes) or 1.2 ksps (1 axis)
1-0	I2C_RD[1:0]	R/W	0h	Defines the I2C read mode 0h = Standard I2C 3-byte read command 1h = 1-byte I2C read command for 16 bit sensor data and conversion status 2h = 1-byte I2C read command for 8 bit sensor MSB data and conversion status 3h = Reserved

8.2 Device_Config_2 Register (Address = 01h) [Reset = 00h]

Device_Config_2 can be used to configure device operation.

Return to Register Map.

Figure 8-2. Device_Config_2 Register

7	6	5	4	3	2	1	0
THR_HYST[2:0]			LP_LN	I2C_Glitch_Filter	Trigger_Mode	Operating_Mode[1:0]	
R/W-0h			R/W-0h	R/W-0h	R/W-0h	R/W-0h	

Table 8-4. Device_Config_2 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-5	THR_HYST[2:0]	R/W	0h	Select hysteresis for the magnetic field thresholds in switch mode (when INT_SEL = 0h = 2 LSB of threshold, 12 bit resolution 1h = 4 LSB of threshold, 12 bit resolution 2h = 8 LSB of threshold, 12 bit resolution 3h = 16 LSB of threshold, 12 bit resolution 4h = 32 LSB of threshold, 12 bit resolution 5h = 64 LSB of threshold, 12 bit resolution 6h = 128 LSB of threshold, 12 bit resolution 7h = 256 LSB of threshold, 12 bit resolution
4	LP_LN	R/W	0h	Selects the modes between low active current or low-noise modes 0h = Low active current mode 1h = Low noise mode
3	I2C_Glitch_Filter	R/W	0h	I2C glitch filter 0h = Glitch filter on 1h = Glitch filter off
2	Trigger_Mode	R/W	0h	Selects a condition which initiates a single conversion based off already configured registers. A running conversion completes before executing a trigger. Redundant triggers are ignored. TRIGGER_MODE is available only during the modes explicitly mentioned in OPERATING_MODE[1:0]. 0h = Conversion Start at I2C Command Bits, DEFAULT 1h = Conversion starts through trigger signal at INT pin
1-0	Operating_Mode[1:0]	R/W	0h	Selects Operating Mode and updates value based on operating mode if device transitions from Wake-up and sleep mode to Standby mode. 0h = Standby Mode (starts new conversion at trigger event) 1h = Sleep mode 2h = Continuous mode 3h = Wake-up and Sleep mode (duty-cycled mode)

8.3 Sensor_Config_1 Register (Address = 02h) [Reset = 00h]

Sensor_Config_1 can be used to configure the magnetic channels enabled and the sleep time for operating in wake and sleep mode.

Return to Register Map.

Figure 8-3. Sensor_Config_1 Register

7	6	5	4	3	2	1	0
MAG_CH_EN[3:0]				SLEEPTIME[3:0]			
R/W-0h				R/W-0h			

Table 8-5. Sesnsor_Config_1 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-4	MAG_CH_EN[3:0]	R/W	0h	Enables data acquisition of the magnetic axis channel 0h = All magnetic channels of OFF, DEFAUT 1h = X channel enabled 2h = Y channel enabled 3h = X, Y channel enabled 4h = Z channel enabled 5h = Z, X channel enabled 6h = Y, Z channel enabled 7h = X, Y, Z channel enabled 8h = XYX channel enabled 9h = YXY channel enabled Ah = YZY channel enabled Bh = XZX channel enabled Ch = X,Y,Z with positive diagnostic offset Dh = X,Y,Z with negative diagnostic offset Eh = Hall resistance check + ADC check Fh = Hall offset check +AFE check
3-0	SLEEPTIME[3:0]	R/W	0h	Selects the time spent in low power mode between conversions when Operating_Mode[1:0] = 3h 0h = 1ms 1h = 5ms 2h = 10ms 3h = 15ms 4h = 20ms 5h = 30ms 6h = 50ms 7h = 100ms 8h = 500ms 9h = 1000ms Ah = 2000ms Bh = 5000ms Ch = 20000ms

Product Folder Links: TMAG3001

8.4 Sensor_Config_2 Register (Address = 03h) [Reset = 00h]

Sensor_Config_2 can be used to configure general sensor operation.

Return to Register Map

Figure 8-4. Sensor_Config_2 Register

7	6	5	4	3	2	1	0
T_Rate	INTB_POL	MAG_THR_DIR	MAG_Gain_CH	Angle_EN[1:0]		X_Y_Range	Z_Range
R/W-0h	R/W-0h	R/W-0h	R/W-0h	R/W-0h		R/W-0h	R/W-0h

Table 8-6. Sensor_Config_2 Register Field Descriptions

Bit	Field	Type	Reset	Description
7	T_Rate	R/W	0h	Temperature Averaging 0h = Single temp conversion if MAG_CH_EN > 0 1h = Filtering per Conv_AVG[2:0]
6	INTB_POL	R/W	0h	Selects the polarity of the interrupt event 0h = INTB pin is set to default high and active low during an interrupt event 1h = INTB pin is set to default low and active high during an interrupt event
5	MAG_THR_DIR	R/W	0h	Selects the direction of threshold check 0h = sets interrupt for external field above the threshold 1h = sets interrupt for external field below the threshold
4	MAG_Gain_CH	R/W	0h	Selects the axis for magnitude gain correction value entered in Sensor_Config_4 register 0h = 1st channel is selected for gain adjustment 1h = 2nd channel is selected for gain adjustment
3-2	Angle_EN[1:0]	R/W	0h	Enables angle calculation, magnetic gain, and offset corrections between two selected magnetic channels 0h = No angle calculation 1h = X 1st, Y 2nd 2h = Y 1st, Z 2nd 3h = X 1st, Z 2nd
1	X_Y_Range	R/W	0h	Select the X and Y axes magnetic range from 2 different options: 0h = ±40mT (TMAG3001x1) or ±120mT (TMAG3001x2) 1h = ±80mT (TMAG3001x1) or ±240mT (TMAG3001x2)
0	Z_Range	R/W	0h	Select the Z axis magnetic range from 2 different options: 0h = ±40mT (TMAG3001x1) or ±120mT (TMAG3001x2) 1h = ±80mT (TMAG3001x1) or ±240mT (TMAG3001x2)

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Product Folder Links: TMAG3001

8.5 THR_Config_1 Register (Address = 04h) [Reset = 00h]

THR_Config_1 can be used to configure X_THRLO, ANGLE_TH_REF, MAG_THRLO via the Threshold1[7:0] field.

Return to Register Map

Figure 8-5. THR_Config_1 Register

7	6	5	4	3	2	1	0
Threshold1[7:0]							
R/W-00h							

Table 8-7. THR_Config_1 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Threshold1[7:0]	R/W	00h	8-bit 2's complement. Configuration functionality and LSB is based on THR_SEL[1:0] bits: If THR_SEL[1:0] = 1h then Threshold1[7:0] = A_THR_REF (Reference threshold for Angle) If THR_SEL[1:0] = 2h then Threshold1[7:0] = X_THR_LO (Low threshold for X channel) If THR_SEL[1:0] = 11b then Threshold1[7:0] = M_THR_LO (Low threshold for Magnitude)

8.6 THR_Config_2 Register (Address = 05h) [Reset = 00h]

THR_Config_2 can be used to configure Y_THRLO, ANGLE_TH_BAND, MAG_THRHI via the Threshold2[7:0] field.

Return to Register Map

Figure 8-6. THR_Config_2 Register

7	6	5	4	3	2	1	0
Threshold2[7:0]							
R/W-00h							

Table 8-8. THR_Config_2 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Threshold2[7:0]	R/W	00h	8-bit 2's complement. Configuration functionality and LSB is based on THR_SEL[1:0] bits: If THR_SEL[1:0] = 1h, then Threshold2[7:0] = A_THR_BAND (Threshold band for Angle) If THR_SEL[1:0] = 2h, then Threshold2[7:0] = Y_THR_LO (Low threshold for Y channel) If THR_SEL[1:0] = 3h, then Threshold2[7:0] = M_THR_HI (High threshold for Magnitude)

Product Folder Links: *TMAG3001*

8.7 THR_Config_3 Register (Address = 06h) [Reset = 00h]

THR_Config_3 is shown in Table 8-9 .

Return to Register Map

Z_THRLO, ANGLE_OFFSET

Figure 8-7. THR_Config_3 Register

7	6	5	4	3	2	1	0
			Threshold3[7:0]				
			R/W-00h				

Table 8-9. THR_CONFIG_3 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Threshold3[7:0]	R/W	00h	8-bit 2's complement. Configuration functionality and LSB is based on THR_SEL[1:0] bits: If THR_SEL[1:0] = 1h, then Threshold3[7:0] = Angle_Offset[7:0] If THR_SEL[1:0] = 2h, then Threshold3[7:0] = Z_THR_LO (Low threshold for Z channel) If THR_SEL[1:0] = 3h, then Threshold3[7:0] = Angle_Offset[7:0]

8.8 Sensor_Config_3 Register (Address = 07h) [Reset = 00h]

Sensor_Config_3 is used to configure the Wake on change, Thresholds functionality, Angle hysteresis and offset.

Return to Register Map

Figure 8-8. Sensor_Config_3 Register

7	6	5	4	3	2	1	0
WOC_SEL[1:0]		THR_SEL[1:0]		Angle_HYS[1:0]		Angle_Offset_EN	ANG_Offset_DIR
R/W-0h		R/W-0h		R/W-0h		R/W-0h	R/W-0h

Table 8-10. Sensor_Config_3 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-6	WOC_SEL[1:0]	R/W	0h	Enables an interrupt response when any of the measured magnetic readings differ from the previous measurements by THR_HYST. 0h = Wake on change disabled 1h = Wake on change from previous angle measurements. ANGLE_EN bits must to be set to a value other than 0h. 2h = Wake on change from previous magnetic field measurements. First X/Y/Z depending on MAG_CH_EN 3h = Reserved
5-4	THR_SEL[1:0]	R/W	0h	Sets the functionality of the THR_Config_1, THR_Config_2 and THR_Config_3 registers 0h = No threshold selected 1h = Angle Thresholds selected. Threshold1[7:0] sets A_THR_REF and Threshold2[7:0] sets A_THR_BAND 2h = B Field Thresholds selected. Threshold1[7:0] sets X_THR_LO, Threshold2[7:0] sets Y_THR_LO, and Threshold3[7:0] sets Z_THR_LO. Gain_X_THR_HI[7:0] sets X_THR_HI, Offset1_Y_THR_HI[7:0] sets Y_THR_HI, and Offset2_Z_THR_HI[7:0] sets Z_THR_HI. 3h = Magnitude Threshold (Button Press) selected. Threshold1[7:0] sets Magnitude_THR_LO and Threshold2[7:0] sets Magnitude_THR_HI. If THR_SEL[1:0] is not equal to 2h, Gain_X_THR_HI[7:0] sets Gain_Config, Offset1_Y_THR_HI[7:0] sets Offset1, Offset2_Z_THR_HI[7:0] sets Offset2, and Threshold3[7:0] sets A_OFFSET
3-2	Angle_HYS[1:0]	R/W	0h	Sets the hysteresis when the angle thresholds are enabled (THR_SEL= 01 b) 0h = 1 degree 1h = 2 degrees 2h = 4 degrees 3h = 8 degrees
1	Angle_Offset_EN	R/W	0h	Enables to add an offset to the final angle value (if THR_SEL=1) 0h = Value from the register Angle_Offset[7:0] is not added to the final angle result 1h = Value from the register Angle_Offset[7:0] is added to the final angle result

Product Folder Links: *TMAG3001*

Table 8-10. Sensor_Config_3 Register Field Descriptions (continued)

Bit	Field	Type	Reset	Description
0	Angle_Offset_DIR	R/W	0h	Indicates to add or subtract the offset value in the Angle_Offset[7:0] to the final angle result. 0h = Value from Angle_Offset[7:0] is added to the final angle result 1h = Value from Angle_Offset[7:0] is subtracted from the final angle result

8.9 INT_Config_1 Register (Address = 08h) [Reset = 00h]

INT_CONFIG_1 is shown in Table 8-11 .

Return to Register Map

Figure 8-9. INT_Config_1 Register

7	6	5	4	3	2	1	0
Result_INT	Threshold_INT	INT_State	INT_Mode[2:0]			INT_POL_EN	MASK_INTB
R/W-0h	R/W-0h	R/W-0h	R/W-0h			R/W-0h	R/W-0h

Table 8-11. INT_Config_1 Register Field Descriptions

Bit	Field	Type	Reset	Description
7	Result_INT	R/W	0h	Enable interrupt response on conversion complete 0h = Interrupt is not asserted when the configured set of conversions are complete 1h = Interrupt is asserted when the configured set of conversions are complete
6	Threshold_INT	R/W	0h	Enable interrupt response on a predefined threshold cross 0h = Interrupt is not asserted when a threshold is crossed 1h = Interrupt is asserted when a threshold is crossed
5	INT_State	R/W	0h	$\overline{INT}$ latched or pulsed 0h = INT\ interrupt latched until clear by a Controller addressing the device 1h = INT\ interrupt pulse for 5us
4-2	INT_Mode[2:0]	R/W	0h	Interrupt Mode Select 0h = No interrupt 1h = Interrupt through $\overline{INT}$ 2h = Interrupt through $\overline{INT}$ and ignore if I2C communication active with the Target. Conversion data lost. 3h = Interrupt through SCL based on width of interrupt 4h = Interrupt through SCL and ignore if I2C communication active irrespective of the Target address. Conversion data lost. 5h = Unipolar Switch Mode. This mode overrides any interrupt function ($\overline{INT}$ trigger is also disabled), and only implements a Switch function. 6h = Omnipolar Switch Mode. This mode overrides any interrupt function ($\overline{INT}$ trigger is also disabled), and only implements a Switch function. 7h = Not valid. defaults to no interrupt
1	INT_POL_EN	R/W	0h	0h = INT_POL bit from Sensor_Config2 is disabled 1h = INT_POL bit from Sensor_Config2 is enabled
0	MASK_INT	R/W	0h	Mask $\overline{INT}$ pin when $\overline{INT}$ connected to GND 0h = $\overline{INT}$ pin is enabled 1h = $\overline{INT}$ pin cannot be used as input or output

8.10 Sensor_Config_4 Register (Address = 09h) [Reset = 00h]

Sensor_Config_4 is used to configure GAIN_CONFIG and X_THR_HI via Gain_X_THR_HI[7:0].

Return to Register Map

Figure 8-10. Sensor_Config_4 Register

7	6	5	4	3	2	1	0
			Gain_X_THR_HI[7:0]				
			R/W-00h				

Table 8-12. Sensor_Config_4 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Gain_X_THR_HI[7:0]	R/W	0h	8-bit 2's complement. Configuration functionality is based on THR_SEL[1:0] bits: If THR_SEL[1:0] = 0h, 1h, or 3h, then Gain_X_THR_HI[7:0] = Gain_Config (Adjusts gain of a selected magnetic channel) If THR_SEL[1:0] = 2h and ANGLE_EN = 0h, then Gain_X_THR_HI[7:0] = X_THR_HI (High threshold for X channel)

8.11 Sensor_Config_5 Register (Address = 0Ah) [Reset = 00h]

Sensor_Config_5 is used to configure Offset_Config_1, Y_THR_HI via Offset1_Y_THR_HI[7:0].

Return to Register Map

Figure 8-11. Sensor_Config_5 Register

7	6	5	4	3	2	1	0
			Offset1_Y_THR_HI[7:0]				
			R/W-00h				

Table 8-13. Sensor_Config_5 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Offset1_Y_THR_HI[7:0]	R/W	00h	8-bit 2's complement. Configuration functionality and LSB is based on THR_SEL[1:0] bits: If THR_SEL[1:0] = 0h, 1h, or 3h, then Offset1_Y_THR_HI[7:0] = Offset_Config_1[7:0] (Adjusts offset of first magnetic channel measured) If THR_SEL[1:0] = 2h and ANGLE_EN = 0h, then Offset1_Y_THR_HI[7:0] = Y_THR_HI[7:0] (High threshold for Y channel)

8.12 Sensor_Config_6 Register (Address = 0Bh) [Reset = 00h]

Sensor_Config_6 is used to configure Offset_Config_2, Z_THR_HI via Offset2_Z_THR_HI[7:0].

Return to Register Map

Figure 8-12. Sensor_Config_6 Register

7	6	5	4	3	2	1	0
Offset2_Z_THR_HI[7:0]							
R/W-00h							

Table 8-14. Sensor_Config_6 Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Offset2_Z_THR_HI[7:0]	R/W	0h	Threshold configuration functionality is set based on THR_SEL[1:0] and ANGLE_EN[1:0] If THR_SEL[1:0] = 0h or 01h or 3h, then Offset2_Z_THR_HI[7:0] = Offset_Config_2[7:0] (adjusts offset of a second magnetic channel) If THR_SEL[1:0] = 2h and ANGLE_EN[1:0] = 0h then Offset2_Z_THR_HI[7:0] = X_THR_HI[7:0] (High threshold for Z channel)

8.13 I2C_Address Register (Address = 0Ch) [Reset = 00h]

This register can be used to configure the I2C Address for TMAG3001.

Return to Register Map

Figure 8-13. I2C_Address Register

7	6	5	4	3	2	1	0
I2C_Address[6:0]							I2C_Address_Update_EN
R/W-00h							R/W-0h

Table 8-15. I2C_Address Register Field Descriptions

Bit	Field	Type	Reset	Description
7-1	I2C_Address[6:0]	R/W	0h	7-bit device address based on the ADDR pin connection. User can change this address to assign a new address if needed. 34h = ADDR is tied to GND 35h = ADDR is tied to VCC 36h = ADDR is tied to SCL 37h = ADDR is tied to SDA
0	I2C_Address_Update_EN	R/W	0h	0h = Use ADDR pin configuration for target address 1h = Use I2C_Address[6:0] for target address

8.14 Device_ID Register (Address = 0Dh) [Reset = 0xh]

This register contains the Device version.

Return to Register Map

Figure 8-14. I2C_Address Register

7	6	5	4	3	2	1	0
Reserved				Version[1:0]		Reserved	
R-0h				R-xh		R-0h	

Table 8-16. Device_ID Register Field Descriptions

Bit	Field	Type	Reset	Description
7-4	Reserved	R	0h	Reserved
3-2	Version[1:0]	R	xh	Device Version 0h = TMAG3001 ±40 mT 2h = TMAG3001 ±120mT
1-0	Reserved	R	0h	Reserved

8.15 Manufacturer_ID_LSB Register (Address = 0Eh) [Reset = 49h]

This register contains the LSB of Manufacturer_ID[15:0].

Return to Register Map

Figure 8-15. Manufacturer_ID_LSB Register

7	6	5	4	3	2	1	0
Manufacturer_ID[7:0]							
R-49h							

Table 8-17. Manufacturer_ID_LSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Manufacturer_ID[7:0]	R	49h	LSB of Manufacturer_ID[15:0]

8.16 Manufacturer_ID_MSB Register (Address = 0Fh) [Reset = 54h]

This register contains the MSB of Manufacturer_ID[15:0].

Return to Register Map

Figure 8-16. Manufacturer_ID_MSB Register

7	6	5	4	3	2	1	0
Manufacturer_ID[15:8]							
R-54h							

Table 8-18. Manufacturer_ID_MSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Manufacturer_ID[15:8]	R	54h	MSB of Manufacturer_ID[15:0]

8.17 Temp_Result_MSB Register (Address = 10h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the MSB output of the most recent temperature conversion. Data is represented in binary 2's complement format. Temperature Sensor Data shows how to convert the Temp_Result[15:0] to temperature.

Return to Register Map

Figure 8-17. Temp_Result_MSB Register

7	6	5	4	3	2	1	0
Temp_Result[15:8]							
R-00h							

Table 8-19. Temp_Result_MSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Temp_Result[15:8]	R	00h	8-bit MSB of Temperature data conversion results.

8.18 Temp_Result_LSB Register (Address = 11h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the LSB output of the most recent temperature conversion. Data is represented in binary 2's complement format. Temperature Sensor Data shows how to convert the Temp_Result[15:0] to temperature.

Return to Register Map

Figure 8-18. Temp_Result_LSB Register

7	6	5	4	3	2	1	0
Temp_Result[7:0]							
R-00h							

Table 8-20. Temp_Result_LSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Temp_Result[7:0]	R	00h	8-bit LSB of Temperature data conversion results.

8.19 X_Result_MSB Register (Address = 12h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the MSB output of the most recent X-channel conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-19. X_Result_MSB Register

7	6	5	4	3	2	1	0
X_Result[15:8]							
R-00h							

Table 8-21. X_Result_MSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	X_Result[15:8]	R	00h	8-bit MSB of X-Channel data conversion results

8.20 X_Result_LSB Register (Address = 13h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the LSB output of the most recent X-channel conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-20. X_Result_LSB Register

7	6	5	4	3	2	1	0
X_Result[7:0]							
R-00h							

Table 8-22. X_Result_LSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	X_Result [7:0]	R	00h	8-bit LSB of X-Channel data conversion results

8.21 Y_Result_MSB Register (Address = 14h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the MSB output of the most recent Y-channel conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-21. Y_Result_MSB Register

7	6	5	4	3	2	1	0
Y_Result[15:8]							
R-00h							

Table 8-23. Y_Result_MSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Y_Result[15:8]	R	00h	8-bit MSB of Y-Channel data conversion results

8.22 Y_Result_LSB Register (Address = 15h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the LSB output of the most recent Y-channel conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-22. Y_Result_LSB Register

7	6	5	4	3	2	1	0
Y_Result[7:0]							
R-00h							

Table 8-24. Y_Result_LSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Y_Result[7:0]	R	00h	8-bit LSB of Y-Channel data conversion results

8.23 Z_Result_MSB Register (Address = 16h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the MSB output of the most recent Z-channel conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-23. Z_Result_MSB Register

7	6	5	4	3	2	1	0
			Z_Result[15:8]				
			R-00h				

Table 8-25. Z_Result_MSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Z_Result[15:8]	R	00h	8-bit MSB of Z-Channel data conversion results

8.24 Z_Result_LSB Register (Address = 17h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the LSB output of the most recent Z-channel conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-24. Z_Result_LSB Register

7	6	5	4	3	2	1	0
			Z_Result[7:0]				
			R-00h				

Table 8-26. Z_RESULT_LSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Z_Result[7:0]	R	00h	8-bit LSB of Z-Channel data conversion results

8.25 Conv_Status Register (Address = 18h) [Reset = 00h]

This register contains the conversion status information.

Return to Register Map

Figure 8-25. Conv_Status Register

7	6	5	4	3	2	1	0
Set_Count[2:0]			POR	Reserved		Diag_Status	Result_Status
R-0h			R/W1C-0h	R-0h		R-0h	R-0h

Table 8-27. Conv_Status Register Field Descriptions

Bit	Field	Type	Reset	Description
7-5	Set_Count[2:0]	R	0h	Rolling Count of Conversion Data Sets
4	POR	R/W1C	0h	Device powered up, or experienced power-on-reset. Bit is clear when host writes back 1. 0h = No POR has occurred 1h = POR occurred
3-2	Reserved	R	0h	Reserved
1	Diag_Status	R	0h	Detect any internal diagnostics fail which include Internal Memory CRC error, $\overline{INT}$ pin error 0h = No diagnostic fail 1h = Diagnostic fail detected
0	Result_Status	R	0h	Conversion data result is ready to be read 0h = Conversion Data not complete 1h = Conversion Data complete

8.26 Angle_Result_MSB Register (Address = 19h) [Reset = 00h]

This register is an 8-bit, read-only register that stores the MSB output of the most recent Angle conversion. Angle_Result[12:0] data is represented in binary 2's complement format with a LSB size of 0.0625°.

Return to Register Map

Figure 8-26. Angle_Result_MSB Register

7	6	5	4	3	2	1	0
Reserved			Angle_Result[12:8]				
R-0h			R-00h				

Table 8-28. Angle_Result_MSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-5	Reserved	R	0h	Reserved
4-0	Angle_Result[12:8]	R	00h	5-bit MSB of Angle data conversion results

Product Folder Links: *TMAG3001*

8.27 Angle_Result_LSB Register (Address = 1Ah) [Reset = 00h]

This register is an 8-bit, read-only register that stores the LSB output of the most recent Angle conversion. Angle_Result[12:0] data is represented in binary 2's complement format with a LSB size of 0.0625°.

Return to Register Map

Figure 8-27. Angle_Result_LSB Register

7	6	5	4	3	2	1	0
Angle_Result[7:0]							
R-00h							

Table 8-29. Angle_Result_LSB Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Angle_Result[7:0]	R	00h	8-bit LSB of Angle data conversion results

8.28 Magnitude_Result Register (Address = 1Bh) [Reset = 00h]

This register is an 8-bit, read-only register that stores the output of the most recent Magnitude conversion. Data is represented in binary 2's complement format.

Return to Register Map

Figure 8-28. Magnitude_Result_ Register

7	6	5	4	3	2	1	0
Magnitude_Result[7:0]							
R-00h							

Table 8-30. Magnitude_Result Register Field Descriptions

Bit	Field	Type	Reset	Description
7-0	Magnitude_Result[7:0]	R	00h	Resultant vector magnitude (during angle measurement) result. This value is constant during 360 degree measurements

8.29 Device_Status Register (Address = 1Ch) [Reset = 00h]

This register contains the device status information.

Return to Register Map

Figure 8-29. Device _Status Register

7	6	5	4	3	2	1	0
Reserved			$\overline{INT}$_RB	Reserved	INT_ER	OTP_CRC_ER	THR_Cross
R-0h			R-0h	R-0h	R/W1CP-0h	R/W1CP-0h	R-0h

Table 8-31. Device_Status Register Field Descriptions

Bit	Field	Type	Reset	Description
7-5	Reserved	R	0h	Reserved
4	$\overline{INT}$_RB	R	0h	Indicates the level that the device is reading back from $\overline{INT}$ pin. 0h = $\overline{INT}$ pin driven low 1h = $\overline{INT}$ pin status high
3	Reserved	R	0h	Reserved
2	INT_ER	R/W1CP	0h	Indicates if $\overline{INT}$ pin error is detected. Bit is clear when host writes 1h. 0h = No $\overline{INT}$ Error detected 1h = $\overline{INT}$ Error detected
1	OTP_CRC_ER	R/W1CP	0h	Indicates if OTP CRC error is detected. Bit is clear when host writes 1h. 0h = No OTP CRC Error detected 1h = OTP CRC Error detected
0	THR_Cross	R	0h	When a threshold crossing is detected, this bit is set. 0h = No threshold crossing detected 1h = Threshold Crossing detected

Product Folder Links: *TMAG3001*

9 Device and Documentation Support

9.1 Documentation Support

9.1.1 Related Documentation

For related documentation see the following:
- Texas Instruments, *Angle Measurement With Multi-Axis Linear Hall-Effect Sensors* application report
- Texas Instruments, *Absolute Angle Measurements for Rotational Motion Using Hall-Effect Sensors* application brief
- Texas Instruments, *Limit Detection for Tamper and End-of-Travel Detection Using Hall-Effect Sensors* application brief

9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

9.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

9.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

9.5 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.6 Glossary

TI Glossary   This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision * (November 2023) to Revision A (March 2024)	Page
• Changed TMAG3001A2 device status from Advanced Information to Production Data..................................	1
• Changed data sheet status from Advanced Information to Production Mixed.....................................	1

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
PTMAG3001A1YBGR	ACTIVE	DSBGA	YBG	6	3000	TBD	Call TI	Call TI	-40 to 125		Samples
PTMAG3001A2YBGR	ACTIVE	DSBGA	YBG	6	3000	TBD	Call TI	Call TI	-40 to 125		Samples
TMAG3001A1YBGR	ACTIVE	DSBGA	YBG	6	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 125	OD	Samples
TMAG3001A2YBGR	ACTIVE	DSBGA	YBG	6	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 125	OE	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and

continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMAG3001A1YBGR	DSBGA	YBG	6	3000	180.0	8.4	0.9	1.41	0.56	2.0	8.0	Q1
TMAG3001A2YBGR	DSBGA	YBG	6	3000	180.0	8.4	0.9	1.41	0.56	2.0	8.0	Q1

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMAG3001A1YBGR	DSBGA	YBG	6	3000	182.0	182.0	20.0
TMAG3001A2YBGR	DSBGA	YBG	6	3000	182.0	182.0	20.0

B —— E —— A

BALL A1
CORNER

D

0.5 MAX

0.20
0.14

BALL TYP

C

SEATING PLANE

⌒ 0.05 C

0.4
TYP

C

0.8
TYP

0.4 TYP

B

A

SYMM
₵

1   2

SYMM
₵

6X ⌀ 0.27
0.23

⊕ 0.015 Ⓜ C A B

D: Max = 1.316 mm, Min = 1.256 mm

E: Max = 0.824 mm, Min = 0.764 mm

4224328/A   05/2018

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing
   per ASME Y14.5M.
2. This drawing is subject to change without notice.

6X (⌀ 0.23)

(0.4) TYP

(0.4) TYP

1   2

A

B   SYMM ₵

C

SYMM ₵
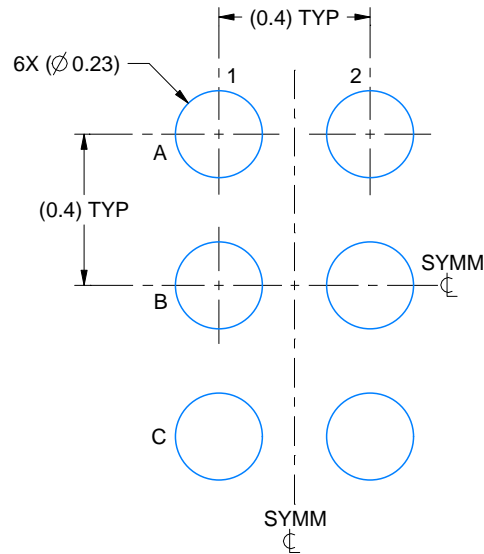
LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 50X

0.05 MAX

(⌀ 0.23)
METAL

SOLDER MASK
OPENING

EXPOSED
METAL

NON-SOLDER MASK
DEFINED
(PREFERRED)

0.05 MIN

METAL UNDER
SOLDER MASK

(⌀ 0.23)
SOLDER MASK
OPENING

EXPOSED
METAL

SOLDER MASK
DEFINED
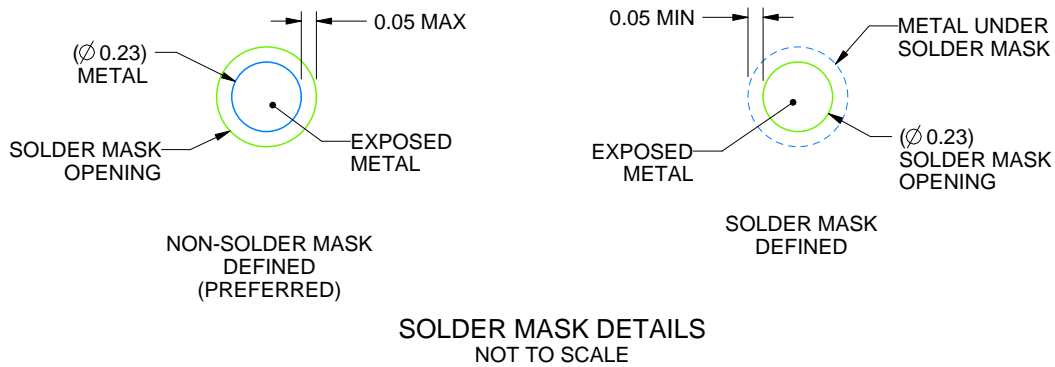
SOLDER MASK DETAILS
NOT TO SCALE

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NOTES: (continued)

3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints.
   See Texas Instruments Literature No. SNVA009 (www.ti.com/lit/snva009).
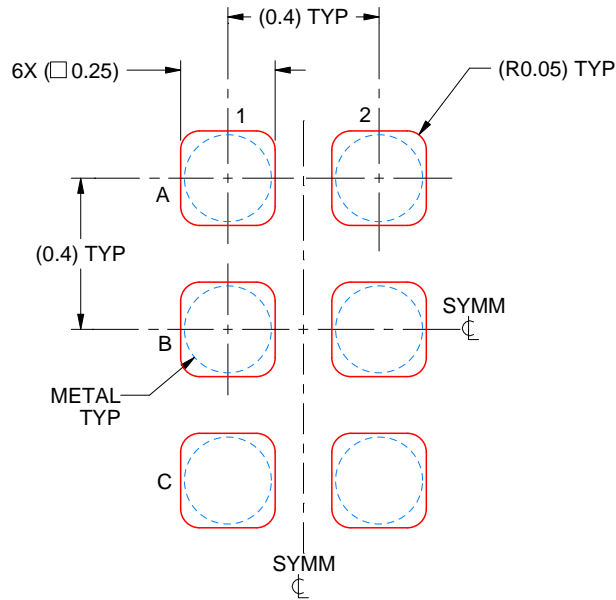
SOLDER PASTE EXAMPLE
BASED ON 0.1 mm THICK STENCIL
SCALE: 50X

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NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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